General Description

The MAX14748 USB battery charger integrates a charger detector, boost/buck converter, and Li+ battery charger with smart power selector to provide fast and safe charging of 2s Li+ battery packs.

The MAX14748 provides support for devices functioning as a UFP/DRP per the USB Type-C 1.1 standard, while also providing detection of legacy USB Battery Charging Specification, Revision 1.2 (BC1.2) compliant chargers in addition to other nonstandard chargers. The programmable Automatic Input Current Limiting (AICL) feature ensures that maximum safe current is drawn from the charging adapter.

The Li+ charger includes an automatic Smart Power Selector™ to simultaneously charge the battery and provide power to the system load. The Smart Power Selector function will supplement the system power with the battery if power from the charging adapter is insufficient. The Li+ charger features JEITA thermal monitoring and charger voltage/current reduction or charger disable.

The MAX14748 is available in a 54-bump, 0.4mm pitch, 3.97mm x 2.77mm x 0.64mm wafer-level package (WLP) and operates over the -40°C to +85°C extended temperature range.

Applications

- Digital Imaging (DSC, DVC)
- Wireless Speakers
- Handheld Barcode Readers

Ordering Information appears at end of data sheet.

Benefits and Features

- Minimize Power Management Footprint Through High Integration
 - 13mΩ (typ) Integrated Battery To System Switch
 - · Thermal Current Limiting
 - DC-DC Converter with Boost and Reverse Buck
 - · High Efficiency
 - 92% in Boost Mode at 1A Output Current and 7.4V Battery Voltage
 - 94% in Reverse Buck Mode at 500mA Output
 - Internal USB Switch for USB D+/D- Data Lines
- Easy-to-Implement Li+ Battery Charging
 - Charges 2s Li-lon Batteries from Legacy 5V USB Adapters
 - 15W Input Power with 3A Type-C Adapter
 - 7.5W Input Power with DCP Adapter
 - 1A System/Charge Current From DCP Adapter
 - 2A System/Charge Current From 3A Type-C Adapter
 - DRP Mode USB Type-C Specification, Rev 1.1 Compliant
 - UFP Mode USB Type-C Specification, Rev 1.1 Support
 - V_{CONN} and Super-Speed Multiplexer Logic Controls
 - · Non-Standard DCP Detection
 - · USB Battery Charging Specification, Rev 1.2 Compliant
- Automatic Input Current Limit (AICL) Power Management
- Support Weak/Dead Batteries Detection
 - · Smart Power Selector
 - Thermistor Monitor
- Various Protection Features
 - · 28V Integrated Overvoltage Protection
 - JEITA Charge Protection
 - ±15kV ESD Protection on USB Adapter Pins

Smart Power Selector is a trademark of Maxim Integrated Products. Inc.



Absolute Maximum Ratings

Voltages Referenced to GND
CHGIN0.3V to +30V
BST0.3V to +16V
SYS to BAT0.3V to +12V
BAT, SYS0.3V to +12V
BYP to CHGIN30V to +0.3V
BYP, THM, ĪNT, SYSOK, FLTIN, FSUS,
LED, SDA, SCL0.3V to 6V
COMP, SET0.3V to V _{CCINT} + 0.3V
CC1, CC2, TDN, TDP, CDN, CDP, V _{CONN} 0.3V to +6V
CC1, CC2, in fault mode through a 10k resistor0.3V to +20V
CDIR0.3V to +6V
VTPU (VTPU-TPU switch open)0.3V to V _{CCINT} + 0.3V
TPU (VTPU-TPU switch open)0.3V to 6 or VTPU + 0.3V
VTPU, TPU Maximum Current
(VTPU-TPU switch closed)100mA to +100mA
BVCEN0.3V to V _{CCINT} + 0.3V

SFOUT, V _{CCINT} , BREG0.3V to min LX	0.3V to V _{SYS} + 0.3V
AGND, DGND, PGND, GND	
Continuous Current into	
CHGIN, SYS	+6.4A
BAT	
Any Other Terminal	
Continuous Power Dissipation	
(multilayer board at +70°C): 9 x 6 Array 5	54-Bump,
3.97mm x 2.77mm 0.4mm Pitch WLP	
(derate 24.46mW/°C)	1.957W
Operating Temperature Range	40°C to +85°C
Junction Temperature	+150°C
Storage Temperature Range	65°C to +150°C
Lead Temperature (soldering, 10s)	+300°C
Soldering Temperature (reflow)	+260°C

Package Thermal Characteristics (Note 1)

WI P

Junction-to-Ambient Thermal Resistance (θ_{JA})40.88°C/W

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Note 1: Package thermal resistances were obtained using the method described in JEDEC specification JESD51-7, using a four-layer board. For detailed information on package thermal considerations, refer to www.maximintegrated.com/thermal-tutorial.

Electrical Characteristics

 $(V_{BAT} = 8.3V, T_A = -40^{\circ}C \text{ to } +85^{\circ}C, \text{ all registers in their default state, unless otherwise noted. Typical values are at <math>V_{CHGIN} = 5.0V, V_{BAT} = 7.4V, V_{SYS} = V_{BATREG}, T_A = +25^{\circ}C.)$

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS				
SUPPLY CURRENT										
BAT Supply Current	I _{BAT}	V _{CHGIN} = 0V or Floating, Type-C detection active		140		μA				
		Low Power mode		25		μA				
CHCIN Supply Current	laa	V _{CHGIN} = +5V, T _A +25°C, ChgEn = 0		5.3		mA				
CHGIN Supply Current	Існд	V _{CHGIN} = +5V, T _A +25°C, Suspend Mode (FSUS = High)		0.98		mA				
CHGIN TO BYP PATH										
Allowed CHGIN Input Voltage Range	V _{CHGIN_RNG}		0		28	V				
CHGIN Detect	V_{BDET}	Rising	3.8	3.9	4.0	V				
Threshold	V_{BDET}	Falling	3.6	3.7	3.8	\ \ \				
01101110	V _{OVP}	Rising	5.59	5.66	5.72	V				
CHGIN Overvoltage Threshold	V _{OVP_F}	Falling	5.56	·		V				
THEOHOL	V _{OVP_H}	Hysteresis		28		mV				

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PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
CHGIN-BYP Resistance	R _{CHGIN_BYP}	V _{CHGIN} = 5V		45		mΩ
CHGIN-BYP Soft-Start Timeout	t _{BYP_SFTTO}	If V _{BYP} has not reached within 50mV of V _{CHGIN} at timeout, a fault is flagged by SysFlt of register 0x02.		100		ms
CHGIN-BYP Soft-Start Current	I _{BYP_SFT}			60		mA
CHGIN-BYP Soft-Start End Comparator	V _{BYP_SFTEND}		15	50	80	mV
CHGIN-BYP Overload Comparator	V_{BYP_OVL}		290	360	420	mV
		SpvChglLim[4:0] = 00100		0.4		
Input Current Limit	I _{LIM}	SpvChglLim[4:0] = 01110		1.5		Α
		SpvChglLim[4:0] = 11101		3		
Input Current Limit Programming Range	I _{LIM_RNG}		0.1		3	А
Input Current Limit Programming Step	I _{LIM_STEP}			100		mA
INTERNAL SUPPLIES						
Internal V _{CCINT} Regulator	V _{CCINT}	V _{CHGIN} = 5V, boost off	4.0	4.3	4.6	V
Boost Regulator BREG	V_{BREG}			4.3		V
V _{CCINT} UVLO	V	V _{CCINT} rising	3.1	3.4	3.7	V
Threshold	V_{UVLO}	V _{CCINT} falling	3.0	3.3	3.6]
V _{CCINT} UVLO Threshold Hysteresis	V _{UVLO_HYS}	Hysteresis		100		mV
		SfOutLvI = 1, V _{CHGIN} = 6V, I _{SFOUT} = 0	3.15	3.3	3.45	
OFOUT L DO V II	V	SfOutLvI = 1, V _{CHGIN} = 6V, I _{SFOUT} = 15mA		2.95		
SFOUT LDO Voltage	V _{SFOUT}	SfOutLvI = 0, V _{CHGIN} = 6V, I _{SFOUT} = 0	5.0	5.25	5.5	V
		SfOutLvI = 0, VCHGIN = 6V, I _{SFOUT} = 15mA		4.9		
SFOUT Maximum Current	ISFOUT_MAX		15			mA

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PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Current Reduce Temperature	T _{CHG_LIM}			120		°C
Thermal Shutdown Temperature	T _{SHUTDOWN}			150		°C
Thermal Shutdown Hysteresis	T _{SHUTDOWN_H}			20		°C
		BYPUVLO[2:0] = 000, V _{BYP} falling		3.8		
		BYPUVLO[2:0] = 001, V _{BYP} falling		3.9		
		BYPUVLO[2:0] = 010, V _{BYP} falling		4.0		
BYP UVLO Threshold	V _{BYPUVLO}	BYPUVLO[2:0] = 011, V _{BYP} falling		4.1		V
BTF OVEO THESHOLD	▼BYPUVLO	BYPUVLO[2:0] = 100, V _{BYP} falling		4.2		V
		BYPUVLO[2:0] = 101, V _{BYP} falling		4.3		
		BYPUVLO[2:0] = 110, V _{BYP} falling		4.4		
		BYPUVLO[2:0] = 111, V _{BYP} falling		4.5		
BYP UVLO Threshold Hysteresis	V _{BYPUVLO_H}			25		mV
		VPChg[2:0] = 000, V _{SYS} rising		5.9		
		VPChg[2:0] = 001, V _{SYS} rising		6.0		
		VPChg[2:0] = 010, V _{SYS} rising		6.1		
SYS UVLO (SYSOK)		VPChg[2:0] = 011, V _{SYS} rising		6.2] ,
Threshold	V _{SYSUVLO}	VPChg[2:0] = 100, V _{SYS} rising	-	6.3		V
		VPChg[2:0] = 101, V _{SYS} rising		6.4		
		VPChg[2:0] = 110, V _{SYS} rising		6.5		
		VPChg[2:0] = 111, V _{SYS} rising	-	6.6		
SYS UVLO Threshold Hysteresis	V _{SYSUVLO_} H			500		mV
BYP-SYS BOOST PATH						
Switching Frequency	f _{BST_SW}			8.0		MHz
Maximum Input Current	I _{BST_MAX}	L = 2.2µH	3			Α
Input Peak Current Limit	I _{BST_LIM_PK}			4.5		Α

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PARAMETER	SYMBOL	CONDIT	IONS	MIN	TYP	MAX	UNITS
			00000		100		
			00001		200		
			00010		300		
			00011		400		
			00100	405	450	495	
			00101		600		
			00110		700		
			00111		800		
			01000		900		1
			01001		1000		1
			01010		1100		
			01011		1200		
			01100		1300		
			01101		1400		
			01110		1500		mA
Forced Input Current	IILIM_F	CurLim1Frc = 1 , CurLim1Set[4:0] =	01111		1600		
Limit			10000		1700		
			10001		1800		
			10010		1900		
			10011		2000		
			10100		2100		
			10101		2200		
			10110		2300		
			10111		2400		
			11000		2500		
			11001		2600		
			11010		2700		
			11011		2800		
			11100		2900		
			11101		3000		
			11110		3100		
			11111		3200		
Efficiency	EFF _{BST}	I _{SYS} = 1000mA, V _E L1 = Bourns SRP4	_{BAT} = 7.4V,		91.6		%
		Charger disabled		,	√ _{BAT} + 0.4		V
SYS Regulation Voltage	V _{SYS_REG}	Charger in prechar	ge, V _{BAT} = 5V		PCHG + 0.4		V
SYS Regulation Voltage Limit	V _{SYS_LIM}	See Battery Charge Diagram	er State		V _{SYS_REG} - 0.2		V

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PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
BYP-SYS BUCK PATH			'			
Switching Frequency	f _{BK_SW}			0.8		MHz
Maximum Output Current	I _{BK_MAX}	L = 2.2µH	500			mA
Short-Circuit Peak Current Limit	I _{BK_LIM}			1.3		А
Efficiency	EFF _{BK}	I _{CHGIN} = 500mA , V _{BAT} = 7.4V, L1 = Bourns SRP4012TA-2R2M		94		%
Output Voltage Range	V _{BK_OUT_RNG}		4		5.5	V
Output Accuracy	V _{BK_OUT_ACC}		-1.5	•	+1.5	%
SYS-BAT CHARGER/SWI	TCH CONTROLLER					
BAT-to-SYS Regulation Voltage	V _{BAT-SYS_ON}			-20		mV
BAT-to-SYS Switch Fast Turn-On Threshold	V _{BAT-SYS_OFF}	V _{SYS} falling		-100		mV
BAT-to-SYS Switch On- Resistance	R _{BAT_SYS}	I _{BAT} = 1A		13		mΩ
Charger Current Soft-Start Time	^t CHG_SOFT			1		ms
PRECHARGE						1
		IPChg[1:0] = 00		5		
Precharge Current	In accord	IPChg[1:0] = 01		10		0/1
Precharge Current	I _{PCHG}	IPChg[1:0] = 10		20		%l _{FCHG}
		IPChg[1:0] = 11, R_{SET} = 20kΩ	27	30	33	
		VPChg[2:0] = 000		5.7		
		VPChg[2:0] = 001		5.8		
		VPChg[2:0] = 010		5.9		
Prequalification	V_{PCHG}	VPChg[2:0] = 011		6.0		V
Threshold	*PCHG	VPChg[2:0] = 100		6.1		_ `
		VPChg[2:0] = 101		6.2		
		VPChg[2:0] = 110		6.3		
		VPChg[2:0] = 111	0] = 111 6.	6.4		
Prequalification Threshold Hysteresis	V _{PCHG_H}			100		mV

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PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
FAST CHARGE		,	'			1
SET Current Gain Factor	K _{SET}			10000		A/A
SET Regulation Voltage	V _{SET}			1		V
		$R_{SET} = 20k\Omega$	0.43	0.5	0.57	
Fact Charge Current	ı	R _{SET} = 20kΩ, T = 25°C	0.475	0.5	0.525	1.
Fast-Charge Current	I _{FCHG}	$R_{SET} = 10k\Omega$		1		A
		$R_{SET} = 4k\Omega$		2.5		
		T_T_IFChg[2:0] = 000		20		
		T_T_IFChg[2:0] = 001		30		
		T_T_IFChg[2:0] = 002		40		
Fast-Charge Current		T_T_IFChg[2:0] = 003		50]
Scaling	I _{FCHG_T}	T_T_IFChg[2:0] = 004		60		%I _{FCHG}
		T_T_IFChg[2:0] = 005		70		1
		T_T_IFChg[2:0] = 006		80		
		T_T_IFChg[2:0] = 007		100		1
1/2 Fast-Charge Current Comparator Threshold	IFC_HALF			50		%I _{FCHG}
1/5 Fast-Charge Current Comparator Threshold	I _{FC_FIFTH}			20		%I _{FCHG}
MAINTAIN CHARGE						
		ChgDone[1:0] = 00		5		
Charge Done Qualification	I _{CHG_DONE}	ChgDone[1:0] = 01		10		%l _{FCHG}
Qualification	_	ChgDone[1:0] = 10, $R_{SET} = 20k\Omega$	18	20	22	
		BatReg[1:0] = 00, T _A = +25°C	8.258	8.3	8.342	
		BatReg[1:0] = 00, T _A = -40°C to +85°C	8.217	8.3	8.383	
BAT Regulation Voltage	V_{BATREG}	BatReg[1:0] = 01		8.4		V
		BatReg[1:0] = 10		8.5		
		BatReg[1:0] = 11		8.6		
		BatReChg[1:0] = 00		200		
BAT Recharge		BatReChg[1:0] = 01		300		1 .,
Threshold	V _{BATRECHG}	BatReChg[1:0] = 10		400	,	mV
		BatReChg[1:0] = 11		500		
CHARGE TIMER		•				,
		PChgTmr[1:0] =00		30		
Maximum		PChgTmr[1:0] = 01		60	,	1
Prequalification Time	alification Time ^t PCHG	PChgTmr[1:0] = 10		120		min
		PChgTmr[1:0] = 11		240	,	

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PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
		FChgTmr[1:0] = 00		75		
Maximum Fast-Charge		FChgTmr[1:0] = 01		150] , _{4:}
Time	t _{FCHG}	FChgTmr[1:0] = 10		300		Min
		FChgTmr[1:0] = 11		600]
		MtChgTmr[1:0] = 00		0		
Maintain Obanna Tina		MtChgTmr[1:0] = 01		15		, Ai
Maintain Charge Time	^t TOCHG	MtChgTmr[1:0] = 10		30		Min
		MtChgTmr[1:0] = 11		60		1
Timer Accuracy	t _{ACC}		-10		+10	%
Timer Extend Threshold	PTIMERX	If charge current is reduced due to I _{LIM} or T _{DIE} , this is the percentage of charge current below which timer clock operates at half speed		50		%
Timer Suspend Threshold	PTIMERSUS	If charge current is reduced due to I _{LIM} or T _{DIE} , this is the percentage of charge current below which timer clock pauses		20		%
THERMISTOR MONITOR	AND NTC DETECTION	ON				
THM Hot Threshold	T4	V _{THM} falling, WarmCoolSel = 0	21.3	23.3	25.3	%V _{TPU}
THIN HOL THESHOL		V _{THM} falling, WarmCoolSel = 1	30.9	32.9	34.9	70 V IPU
THM Warm Threshold	Т3	V _{THM} falling, WarmCoolSel = 0	30.9	32.9	34.9) . %V _{TPU}
Triwi waim Triicsiioid		V _{THM} falling, WarmCoolSel = 1	46.5	50	53.5	70 V IPU
THM Cool Threshold	T2	V _{THM} rising, WarmCoolSel = 0 or 1	62.5	64.5	66.5	%V _{TPU}
THM Cold Threshold	T1	V _{THM} rising, WarmCoolSel = 0 or 1	71.9	73.9	75.9	%V _{TPU}
THM Disable Threshold	V _{THM_DIS}	V _{THM} rising	91.0	93.0	95.0	%V _{TPU}
THM Threshold Hysteresis	V _{THM_DIS_H}			60		mV
JEITA BAT Voltage Reduction	V _{BAT_} JEITA			300		mV
THM Input Leakage	I _{THM_LK}		-1		+1	μA
THM Detection Time	tTHM_DET			0.35		ms
DIGITAL I/O (SDA, SCL, F	LTIN, INT, SYSOK,	FSUS, LED, CDIR)				
Leakage Current	I _{IO_LK}		-1		+1	μA
Logic Input High-Voltage	V _{IO_IH}		1.4			V
Logic Input Low-Voltage	V _{IO_IL}				0.5	V
Logic Output Low-Voltage	V _{IO_OL}	I _{OL} = 4mA			0.4	V
FSUS Input Pulldown Resistance	R _{FSUS_PD}			470		kΩ
SDA, SCL Bus Low- Detection Current	I_{PD}	V _{SDA} = V _{SCL} = 0.4V		0.2	0.4	μА
SCL Clock Frequency	f _{SCL}	Note 3	0		400	kHz

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PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Bus Free Time Between a STOP and START Condition	t _{BUF}		1.3			μs
START Condition (Repeated) Hold Time	tHD_SDA	Note 3	0.6			μs
Low Period of SCL Clock	t _{LOW}		1.3			μs
High Period of SCL Clock	tHIGH		0.6			μs
Setup Time for a Repeated START Condition	^t su_sta		0.6			μs
Data Hold Time	t _{HD_DAT}	Note 4	0		0.9	μs
Data Setup Time	t _{SU_DAT}	Note 4	100			ns
Setup Time for STOP Condition	tsu_sto		0.6			μs
Spike Pulse Widths Suppressed by Input Filter	t _{SP}	Note 5		50		ns
BC1.2 DETECTION						
V _{DP_SRC} Voltage	V _{DP_SRC} /V _{SRC06}	I _{LOAD} = 0 to 200μA	0.5	0.6	0.7	V
V _{DM_SRC} Voltage	V _{DM_SRC} /V _{SRC06}	I _{LOAD} = 0 to 200μA	0.5	0.6	0.7	V
V _{D33} Voltage	V _{SRC33}	I _{LOAD} = 0 to 365μA	2.6		3.4	V
V _{DAT_REF} Voltage	V _{DAT_REF}		0.25	0.32	0.4	V
V _{LGC} Voltage	V_{LGC}		1.5	1.7	1.9	V
I _{DM_SINK} Current	I _{DM_} SINK ^{/I} DATSINK	0.15V to 3.6V	55	80	105	μA
I _{DP_SRC} Current	I _{DP_SRC} /I _{DCD}	0V to 2.5V	7	10	13	μA
R _{DM_DWN} Resistor	R _{DM_DWN} /R _{DWN15}		12	20	24	kΩ
I _{WEAK} Current	I _{WEAK}		0.01	0.1	0.5	μA
V _{BUS31} Threshold	V _{BUS31}	DP and DN pins. Threshold in percent of V _{BUS} voltage 4V < V _{BUS} < 5.5V	26	31	36	%
V _{BUS47} Threshold	V _{BUS47}	DP and DN pins. Threshold in percent of V _{BUS} voltage 4V < V _{BUS} < 5.5V	43.3	47	51.7	%
V _{BUS64} Threshold	V _{BUS64}	DP and DN pins. Threshold in percent of V _{BUS} voltage 4V < V _{BUS} < 5.5V	57	64	71	%

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PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Charger Detection Debounce	tCDDEB		45	50	55	ms
Primary-to-Secondary Timer	t _{PDSDWAIT}		27	35	39	ms
Proprietary Charger Debounce	t _{PRDEB}		5	7.5	10	ms
Data Contact Detect Timeout	tDCDTMO	DCD2s = 0 DCD2s = 1	700 1.8	800 2.0	900 2.2	- ms
DP/DN Overvoltage Debounce	[†] OVDXDEB		90	100	110	μs
OVDX Comparator	OVDX _{THRESHOLD}	Rising Falling	0 -0.04		0.15 +0.08	V
CDP/CDN Pulldown Resistor	R _{CDP/CDN_PD}		3	6	12	mΩ
TYPE-C DETECTION						
V _{CONN} Switch Voltage Drop	V_{CONN_REQ}	$V_{CONN} = 5.5V, I_{CC_LOAD} = 20mA$	5.5		5.6	V
V _{CONN} Bulk Capacitance	C _{VCONN}		10		220	μF
CC Pin Operational Voltage Range	V _{CONN_RNG}				5.5	V
CC Pin Voltage in DFP 3.0A Mode	V _{CC_PIN30}		3.1			V
CC Pin Voltage in DFP 1.5A Mode	V _{CC_PIN15}		1.85			V
CC Pin Low-Power Mode Pulldown Resistance	R _{LPPD_CC_}			170		kΩ
CC Pin Low-Power Mode Voltage Threshold	V _{LP_CC} _	Rising		0.7		V
CC Pin Clamp Requirements	V _{CC_PIN_} CLAMP	60μA ≤ I _{CC} _≤ 600μA		1.1	1.32	V
CC UFP Pulldown Resistance	R _{DUFP_CC_}		4.59	5.1	5.61	kΩ
CC DFP 0.5A Current Source	I _{DFP0.5} _CC_		72	80	88	μА
CC DFP 1.5A Current Source	I _{DFP1.5} _CC_		165.6	180	194.4	μА
CC DFP 3.0A Current Source	I _{DFP3.0_CC} _		303.6	330	356.4	μА
CC R _A and R _D Threshold	V _{RA_RD0.5}	Rising Falling	0.16 0.15	0.2	0.25	V
CC UFP 0.5A R _D Threshold	V _{UFP_RD0.5}	Rising Falling	0.62 0.61	0.66	0.7	V
CC UFP 1.5A R _D Threshold	V _{UFP_RD1.5}	Rising Falling	1.17 1.16	1.23	1.31	V
CC V _{CONN} Detect Threshold	V _V CONN_DET	Rising Falling	2.11	2.25	2.4	V

 $(V_{BAT} = 8.3V, T_A = -40^{\circ}C \text{ to } +85^{\circ}C, \text{ all registers in their default state, unless otherwise noted. Typical values are at <math>V_{CHGIN} = 5.0V, V_{BAT} = 7.4V, V_{SYS} = V_{BATREG}, T_A = +25^{\circ}C.)$

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
CC DFP V _{OPEN} Detect	V	Rising	1.51	1.575	1.65	- V
Threshold	V _{DFP_} VOPEN	Falling	1.5]
CC DFP V _{OPEN} with	V	Rising	2.46	2.6	2.75	V
3.0A Detect Threshold	V _{DFP_} VOPEN3A	Falling	2.45			V
V _{BUS} Valid	V _{BDET}	Rising	3.8	4.12	4.4	V
V _{BUS} Valid Hysteresis	V _{BDET_H}	Falling hysteresis		0.7		V
V _{BUS} Discharge Value	V _{SAFE0V}	Falling. Voltage level where a connected UFP will find V _{BUS} removed.	0.6	0.7	0.84	V
		Rising hysteresis		100		mV
CC Pin Power-Up Time	^t CLAMPSWAP	The maximum time allowed from removal of voltage clamp to attachment of the 5.1k resistor			15	ms
Type-C CC Pin Detection Debounce	^t CCDEB		100		200	ms
Type-C Debounce	t _{PDDEB}		10		20	ms
Type-C Quick Debounce	t _{QDEB}		0.9	1	1.9	ms
V _{BUS} Debounce	t _{VBDEB}		9	10	11	ms
V _{SAFE0V} Debounce	t _{VSAFE0VDEB}		9	10	11	ms
Type-C Error Recovery Delay	^t ERRORRECOVERY		25			ms
Type-C DRP Toggle Time	t _{DRP}		50		100	ms
Duty Cycle of DRP Swap	D _{DRP}	Duty cycle of UFP to DFP role swap	30		70	%
DRP Transition Time	^t DRPTRAN	Time a role swap from DFP to UFP or reverse is completed			1	ms
DRP Lock Time	^t DRPLOCK	DRP Lock wait time before transition to unattached state	100		150	ms
V _{CONN} Enable Time	^t vconnon	Time from when V _{BUS} is supplied in DFP mode in state Attach.DFP. DRPWait			10	ms
V _{CONN} Disable Time	^t /CONNOFF	Time from UFP detached or as directed by I ² C command until V _{CONN} is removed			35	ms

 $(V_{BAT}$ = 8.3V, T_{A} = -40°C to +85°C, all registers in their default state, unless otherwise noted. Typical values are at V_{CHGIN} = 5.0V, V_{BAT} =7.4V, V_{SYS} = V_{BATREG} , T_{A} = +25°C.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
CC Pin Current Change Time	^t SINKADJ	Time from CC pin changes state in UFP mode until current drawn from DFP reaches new value			60	ms
V _{BUS} On-Time	t _{VBUSON}	Time from UFP is attached until V _{BUS} On			275	ms
V _{BUS} Off-Time	t _{VBUSOFF}	Time from UFP is detached until V _{BUS} reaches V _{SAFE0V}			650	ms
BVCEN Output Low- Voltage	V _{BVCEN_OL}	I _{SINK} = 1mA			0.4	V
BVCEN Output High- Voltage	V _{BVCEN_} OH	I _{SOURCE} = 1mA	V _{CCINT} - 0.4			V

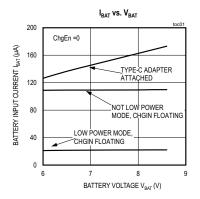
- Note 2: All devices are 100% production tested at $T_A = +25$ °C. Limits over the operating temperature range are guaranteed by design and characterization.
- Note 3: f_{SCL} must meet the minimum clock low time plus the rise/fall times.
- Note 4: The maximum t_{HD:DAT} has to be met only if the device does not stretch the low period (t_{LOW}) of the SCL signal.

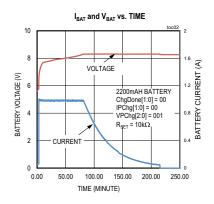
 Note 5: Filters on SDA and SCL suppress noise spikes at the input buffers and delay the sampling instant.

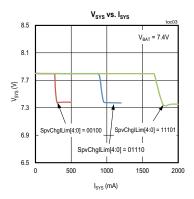
MAX14748

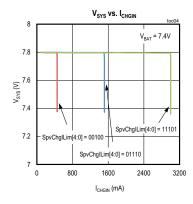
Typical Operating Characteristics

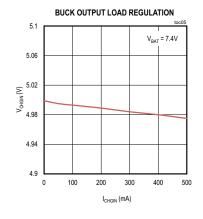
 $(V_{BAT} = 8.5V, T_A = -20^{\circ}C \text{ to } +70^{\circ}C, \text{ all registers in their default state, unless otherwise noted. Typical values are at <math>V_{CHGIN} = 5.0V, V_{BAT} = 7.4V, V_{SYS} = V_{BATREG}, T_A = +25^{\circ}C.)$

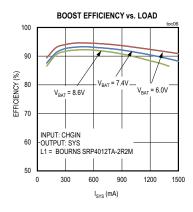


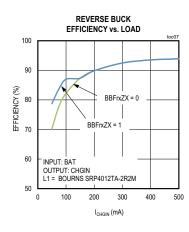


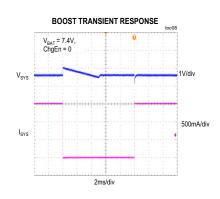


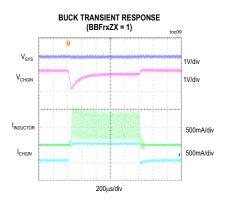






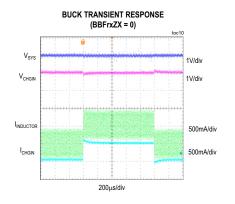


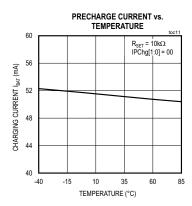


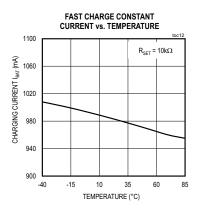


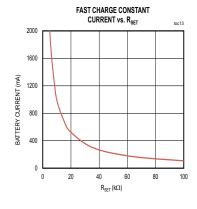
Typical Operating Characteristics (continued)

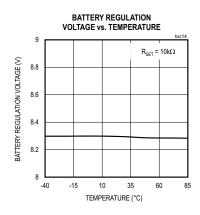
 $(V_{BAT} = 8.5V, T_A = -20^{\circ}C \text{ to } +70^{\circ}C, \text{ all registers in their default state, unless otherwise noted. Typical values are at <math>V_{CHGIN} = 5.0V, V_{BAT} = 7.4V, V_{SYS} = V_{BATREG}, T_A = +25^{\circ}C.)$

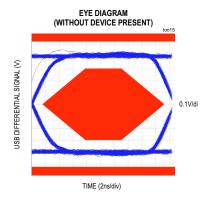






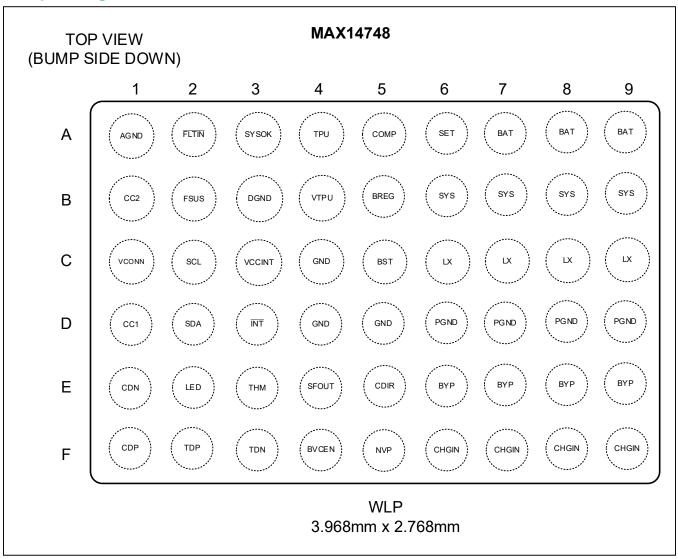








Bump Configuration



Bump Descriptions

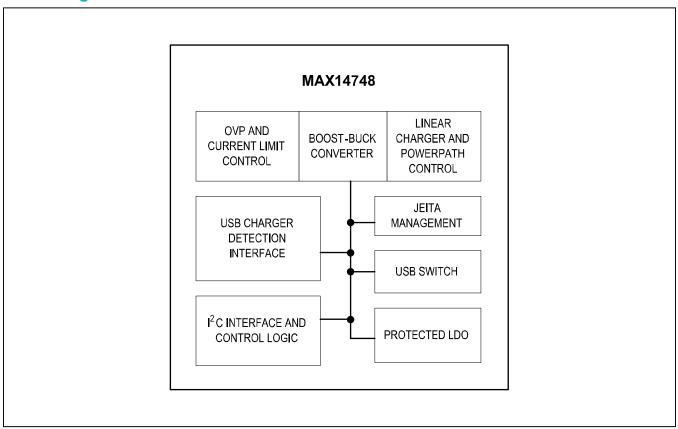
BUMP	NAME	FUNCTION
A1	AGND	Analog Ground.
A2	FLTIN	Charger Fault Input. Logic-low on this pin forces the charger into a fault state and generates an interrupt. See Register 0x35 description for more information. Connect to digital I/O supply if not used.
А3	SYSOK	Open-Drain Status Output of SYS Regulation. When V_{SYS} is above the SYS UVLO threshold and Boost is active, this output is high-impedance. When V_{SYS} is below the SYS UVLO threshold, this output is low. Leave unconnected if not used.
A4	TPU	High-Side of Internal Resistor for THM Detection. Connect a 10k resistor between this pin and THM.
A5	COMP	Buck/Boost Converter Compensation Connection. Connect a 3.9nF capacitor for internal Buck/Boost compensation
A6	SET	External Resistor Connection for Fast Charge Current Setting. Connect a resistor to this pin to set the fast charge current. Other charge currents are set as a proportion of fast charge current based on I ² C register settings.
A7–A9	BAT	Battery Connection. Connect a 2s Li-ion+ battery from BAT to GND. Bypass to PGND with a parallel combination of a 0.1μF capacitor and an effective 10μF - 30μF capacitor. Keep the capacitors as close to BAT as possible and keep the stray inductance and resistance of the trace from BAT to the battery terminal as low as possible.
B1	CC2	USB Type-C CC2. Connect to CC2 on USB Type-C connector.
B2	FSUS	Force Suspend Input. Logic-high on this pin causes the input limiter to open and input current from CHGIN is reduced to zero. This pin is internally pulled to GND through a $470k\Omega$ (typ) resistor and has no effect if FSUSMsk = 1.
В3	DGND	Digital Ground.
B4	V _{TPU}	External Voltage Input for TPU connection. Connect to external supply or V _{CCINT} .
B5	BREG	Bypass for Internal Switching Converter Supply. Bypass with 1µF capacitor to AGND.
B6-B9	SYS	System Load Connection. Connect SYS to the system load. Bypass to PGND with a parallel combination of a 0.1µF capacitor and an effective 22µF capacitor. (Note: there is a diode between SYS and BAT)
C1	V _{CONN}	External V _{CONN} Supply Input. Leave unconnected if not used.
C2	SCL	I ² C Serial Clock Input. Connect an external pull-up resistor.
C3	V _{CCINT}	Bypass For Internal Analog Supply. Bypass with 1µF capacitor to GND.
C4, D4, D5	GND	Ground.
C5	BST	Charge Pump Connection. Connect a 0.1µF capacitor between BST and LX.
C6, C7, C8, C9	LX	Switching Node of Boost Converter. Connect a 1.5µH or 2.2µH inductor between LX and BYP. See <i>Applications Information</i> section for more details.
D1	CC1	USB Type-C CC1. Connect to CC1 on USB Type-C connector.
D2	SDA	I ² C Serial Data Input/Output. Connect an external pullup resistor.
D3	ĪNT	Active-Low, Open-Drain Interrupt Output. Connect an external pullup resistor.
D6, D7, D8, D9	PGND	Power Ground.

Bump Descriptions (continued)

BUMP	NAME	FUNCTION
E1	CDN	USB Connector D-Input. Leave unconnected if not used.
E2	LED	LED Charging Status Indicator. Open-drain output indicating battery charging status. When LEDAuto = 1 and a temperature fault is detected, the output is pulsed at 50% duty cycle for a period of 1.5s. When a charge timer expires or SysFlt fault occurs, LED is pulsed at 50% for a period of 0.15s. When LEDAuto = 0, the open-drain output is controlled by the LEDCtrl bit. Connect this pin to GND if unused.
E3	ТНМ	Battery Temperature Thermistor Measurement Connection. This pin is used for NTC thermistor presence detection and JEITA compliant temperature control.
E4	SFOUT	Output of overvoltage protected LDO powered from CHGIN. Bypass SFOUT with a 1µF ceramic capacitor to GND.
E5	CDIR	USB Cable Orientation Open-drain Output. When CC1 is active, this output is pulled low. Otherwise, this output is high-impedance. Leave unconnected if not used.
E6-E9	BYP	Bypass Connection. Bypass to PGND with a parallel combination of a 0.1µF capacitor and an effective 10µF capacitor.
F1	CDP	USB Connector D+ Input. Leave unconnected if not used.
F2	TDP	USB Transceiver D+ Connection. Connect TDP to device microprocessor USB transceiver D+ line. Leave unconnected if not used.
F3	TDN	USB Transceiver D- Connection. Connect TDN to device microprocessor USB transceiver D- line. Leave unconnected if not used.
F4	BVCEN	External V _{CONN} Supply Enable Output. Push-pull output between V _{CCINT} and GND. Leave unconnected if not used.
F5	NVP	Negative Voltage PFET Gate Control. Leave unconnected if not used.
F6-F9	CHGIN	USB Charger Input. Bypass this pin with a 1µF capacitor to PGND.

Note: All capacitance values listed in this document refer to effective capacitance. Be sure to specify capacitors that will meet these requirements under typical system operating conditions taking into consideration the effects of voltage and temperature.

Block Diagram



Detailed Description

The MAX14748 is a battery charger with a Smart Power Selector that safely charges two Li+ cell in accordance with JEITA specifications*.

Input OVP

The MAX14748 CHGIN input is protected by an internal N-channel FET. The device monitors the voltage at CHGIN and, if CHGIN is greater than $V_{\text{OVP}},$ switches off the internal FET to prevent damage to the device. If V_{CHGIN} is above the overvoltage threshold or below the USB valid voltage threshold, the MAX14748 enters overvoltage lockout (OVLO). During OVLO, the internal circuits remain powered, the SYSOK pin is high-impedance, and an interrupt is asserted. During OVLO, the charger turns off and the system load switch closes, allowing the battery to power SYS.

Negative Voltage Protection (NVP)

The MAX14748 provides a gate protection circuit for an external PFET that protects against negative voltages on V_{BUS}. NVP pin drives the gate of the external PFET. If a negative voltage is present on V_{BUS}, e.g., by a backwards connector, the NVP turns off the external PFET, therefore providing negative voltage protection.

Low Power Mode

The MAX14748 features a Low Power mode, which reduces the battery current consumption from 25µA to 140µA. To enter Low Power mode, write 1 to LowPowEn (Register 0x33[7]). To manually exit Low Power mode, set LowPowAbort (Register 0x33[1]) to 1. If a DFP pullup connect to CC1/CC2 is detected, the device automatically exits Low Power mode and resumes normal operations.

Input Current Limiter

The primary function of the input limiter is supplying power from the external adapter at CHGIN to the system

load and battery charger. In addition, it performs several other functions to optimize use of the available power efficiently and safely, including:

- CHGIN Input Current Limiting: The CHGIN input current is limited to prevent input overload. The current limit can be automatically selected through charger detection to match the capabilities of the source. The result is indicated by SpvChgllim[4:0] in register 0x22. See <u>Table 1a</u> for more details. It can also be manually set through CurLim1Frc and CurLim1Set[4:0] in register 0x21. <u>Figure 1</u> illustrates how the current limit setting is selected.
- 2) Thermal Limiting: In case the die temperature exceeds the normal limit (T_{CHG_LIM}), the MAX14748 will attempt to limit temperature increase by reducing the input current at CHGIN. In this condition, the system load has priority over charger current, so the input current is first reduced by lowering the charge current. If the junction temperature continues to rise and reaches the maximum operating limit (T_{BUS_LIM}), no input current is drawn from CHGIN and the battery powers the entire system load.
- 3) Adaptive Battery Charging: While the system is powered from CHGIN, the charger draws power from SYS to charge the battery. If the total load exceeds the input current limit, the battery supplies supplmental current to the load.
- 4) Adaptive Input Current Limiting: If the MAX14748 input current limit is programmed in such a way that the adapter voltage collapses due to resistive drop, current limiting, or poor load transient response, the AICL loop allows the MAX14748 to regulate the input voltage above a value needed to ensure proper operation. Figure 2 illustrates high-level operation of the AICL block and associated parameters are found in the registers 0x2C to 0x2E.

^{*}JEITA (Japan Electronics and Information Technology Industries Association) Standard, A Guide to the Safe Use of Secondary Lithium Ion Batteries on Notebook–Type Personal Computers, April 20, 2007.

Table 1a. Automatic Input Current Limit Control

ChgTyp[1:0]	PrChgTyp[2:0]	CCIStat[1:0]	SDPMaxCur[1:0]	CDPMaxCur[1:0]	I _{LIM}	SpvChgllim[4:0]
"xx"	"xxx"	"11 = 3A"	"00"	"0"	3A	0x1D
"11 = 1.5A"	"xxx"	"11 = 3A"	"xx"	"x"	3A	0x1D
"xx"	"110 = 3A"	"xx"	"xx"	"x"	3A	0x1D
"xx"	"101 = 2.4A"	"00" or "01 = 500mA" or "10 = 1.5A"	"xx"	"x"	2.4A	0x17
"xx"	"100 = 2A" or "001 = 2A"	"00" or "01 = 500mA" or "10 = 1.5A"	"xx"	"x"	2A	0x13
"1x = 1.5A"	"000" or "010 = 500mA"	"00" or "01 = 500mA" or "10 = 1.5A"	"xx"	"x"	1.5A	0x0E
"1x = 1.5A"	"000" or "010 = 500mA" or "011 = 1A"	"10 = 1.5A"	"xx"	"x"	1.5A	0x0E
"xx"	"011 = 1A"	"00" or "01 = 500mA"	"xx"	"x"	1A	0x09
"01 = 500mA"	"000" or "010 = 500mA"	"00" or "01 = 500mA"	"xx"	"x"	0.5A	0x04
"01 = 500mA"	"000"	"10 = 1.5A" or "11 = 3A"	01	"x"	0.5A	0x04
"01 = 500mA"	"000"	"10 = 1.5A" or "11 = 3A"	10	"X"	1.0A	0x09
"01 = 500mA"	"000"	"10 = 1.5A" or "11 = 3A"	11	"x"	1.5A	0x0E
"10 = 1.5A"	"000"	"11 = 3A"	XX	"1"	1.5A	0x0E
"00"	"xxx"	"xx"	"xx"	"x"	NA	NA

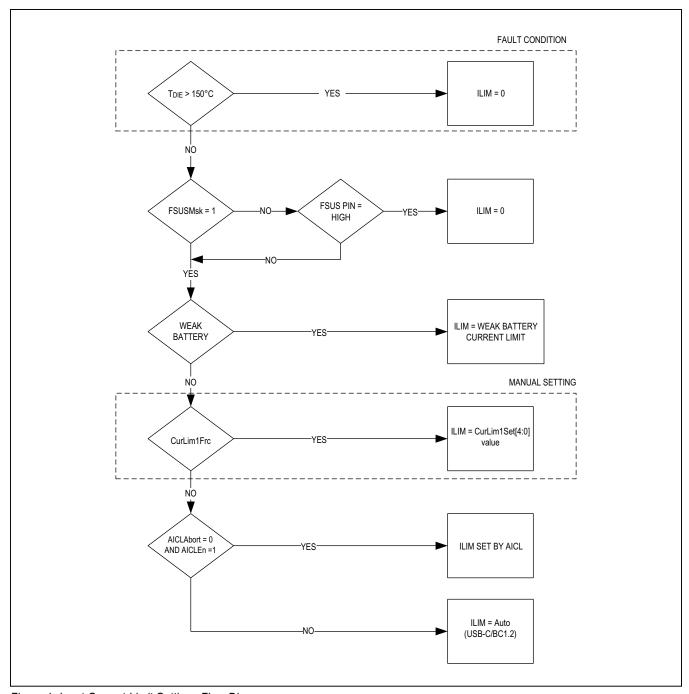


Figure 1. Input Current Limit Settings Flow Diagram

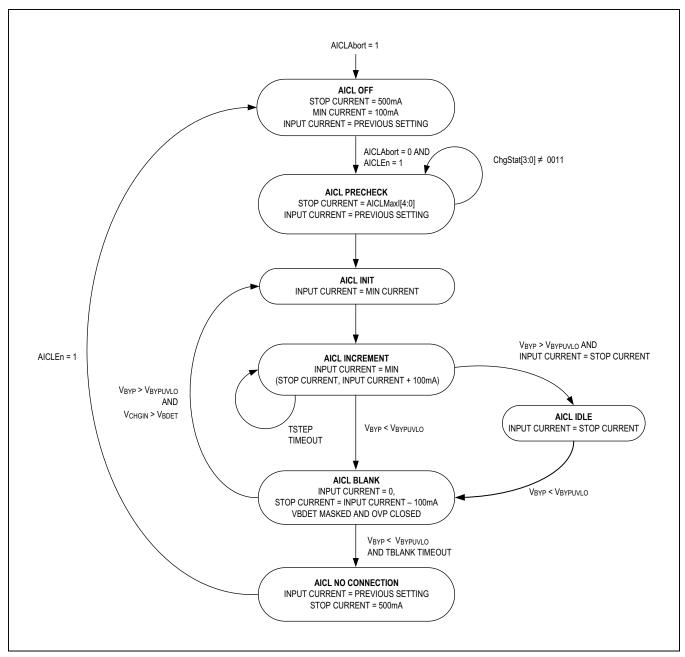


Figure 2. AICL Operation Flow Diagram

Boost Converter with Reverse Buck Boost Mode

The MAX14748 boost converter operates as either a current-limited voltage source, or current source, depending on the charger operational state. When a valid USB voltage is present at CHGIN, and the charger is disabled, V_{SYS} is regulated to V_{BAT} + 400mV. If the charger is in precharge mode, V_{SYS} is regulated to V_{PCHG} + 400mV. When the system is in fast-charge mode, the boost converter operates as a current source, delivering current into the SYS node that is shared by the battery and system loads.

The boost converter current limit may be acted upon by multiple system blocks, including the programmed input current limit, thermal status, charging current, SYS regulation voltage block, and battery termination voltage block. The minimum requested current from these blocks at any given time determines the active current limit in the boost.

Reverse Buck Mode

The CHGIN-SYS switching converter may operate as a buck converter when needed to supply a load attached to CHGIN. The load may be a Type-C sink or some other proprietary device.

If Type-C DRP operation is enabled, the buck converter can be enabled by the Type-C state machine. The output voltage of the buck can be programmed from 4V to 5.5V in 0.1V steps by writing to BuckVSet[3:0], however, it is not recommended to change the output voltage when the buck is active.

The output of the buck converter turns off when a fault occurs. The specific fault occurred is indicated by DCDCILim, DCDCRunAway, DCDCPGood status bits (register 0x04). See Register Descriptions for more details. When the buck is disabled due to a fault, both VBUSDet (register 0x07) and VSAFE0V (register 0x0A) change to 0. After the fault condition is removed, the buck converter can be restarted by writing 1 to CCSnkRst, CCSrcRst, CCForceError, or USBCRset auto-reset bits.

Smart Power Selector

The Smart Power Selector seamlessly distributes power between CHGIN, battery (BAT) and the system (SYS). The basic modes of operation of the smart power selector are:

- 1. With a valid external power source:
 - The external power source at CHGIN is the primary source of energy.
 - b. The battery is the secondary source of energy.
 - c. Energy delivery to SYS is the highest priority.
 - d. Any energy that is not required by SYS is available to the battery.
- 2. With no power source available at CHGIN:
 - a. The battery is the primary source of energy.
 - b. Energy delivery to SYS has the highest priority.
- 3. With a Type-C Sink or other load present at CHGIN:
 - a. The battery is the primary source of energy.
 - b. Energy delivery to SYS is the highest priority.
 - c. Energy delivery to BYP is the second highest priority.

4. SYS Regulation Voltage:

- a. When the charger path is enabled and the charger is disabled, V_{SYS} is regulated to V_{BAT} + 400mV and BAT switch is off.
- b. When the charger is enabled but in a non-charging state such as maitain charge done, thermistor suspend, or timer fault, V_{SYS} is regulated to V_{BAT} + 400mV and BAT switch is off.
- c. When the input charger path is enabled and the battery is charging in prequalification, V_{SYS} is regulated to V_{PCHG} + 400mV. Charge current is reduced when V_{SYS} approaches V_{PCHG} + 200mV.
- d. When the input charger path is enabled and the battery is charging in fast-charge or maintain charge done, the BAT switch is closed and V_{SYS} = V_{BAT}. In maintain charge done state, the connection between SYS and BAT acts as an ideal diode. Therefore, when V_{SYS} drops below V_{BAT}, the BAT switch is turned fully on and the battery supplements the SYS load along with the current from CHGIN.
- e. When the switching converter is enabled as a reverse buck, the BAT switch is closed and V_{SYS} = V_{BAT}.

Short-Circuit Protection

The MAX14748 provides short-circuit protection to the power nodes. When SYS is shorted to ground, input current from CHGIN is limited by boost converter current limit. Note in this case, FET diode from BAT-SYS prevents control of FET BAT-SYS current. Battery current is not limited by the MAX14748 and a pack protector is needed to limit the battery current.

When either BYP or CHGIN is shorted to ground, the current from BAT is limited by the reverse buck converter.

USB Type-C 1.1

USB Type-C 1.1 UFP and DRP Support

The MAX14748 provides support for devices functioning as a Upstream Facing Port (UFP) or Dual Role Port (DRP) per the current USB Type-C 1.1 specification. When acting as a power source in DRP mode, the MAX14748 can provide a 5V VBUS on the CHGIN pin through operation of the reverse buck converter. The USB Type-C VCONN supply is provided externally via the VCONN pin, and switched internally onto one of the CC pins. An open-drain output pin, BVCEN, is provided to enable the external VCONN supply based on the Type-C state machine output. BVCEN is a push-pull output between GND and VCCINT.

USB BC1.2 Compliant and Nonstandard Charger Support

The BC1.2 charger detection and special charger detection routine is embedded within the Type-C state machine. The BC1.2 and Special Charger detection routine runs always when the state machine enters the 'AttachWait. SNK' state of the USB Type-C 1.1 state-machine.

USB Type-C Adapter Insertion

<u>Figure 3a</u> and <u>Figure 3b</u> depict the general timings when a USB Type-C adapter is attached. For more information on the behavior and timings of the USB Type-C 1.1 statemachine, please refer to the USB Type-C specification.

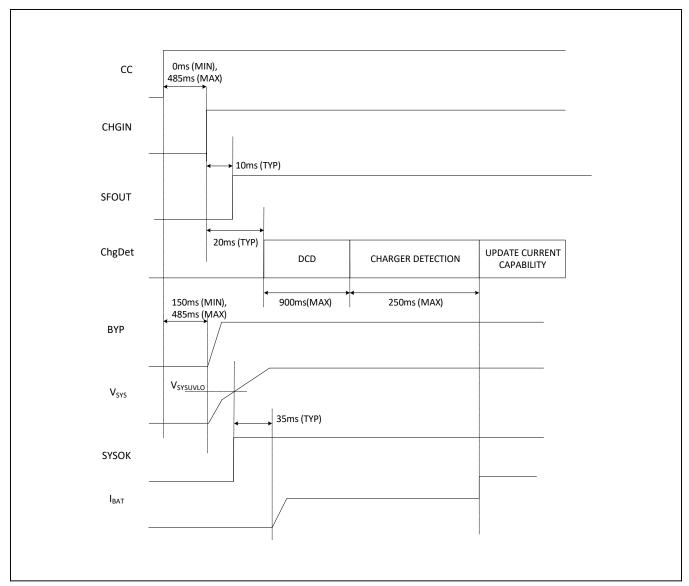


Figure 3a. Type-C Adapter Insertion (CHGINILimGate = 0)

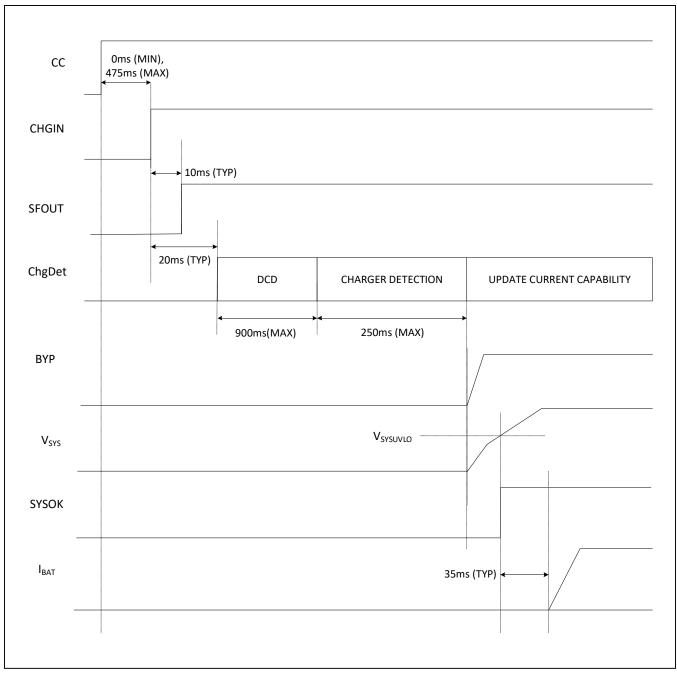


Figure 3b. Type-C Adapter Insertion (CHGINILimGate = 1)

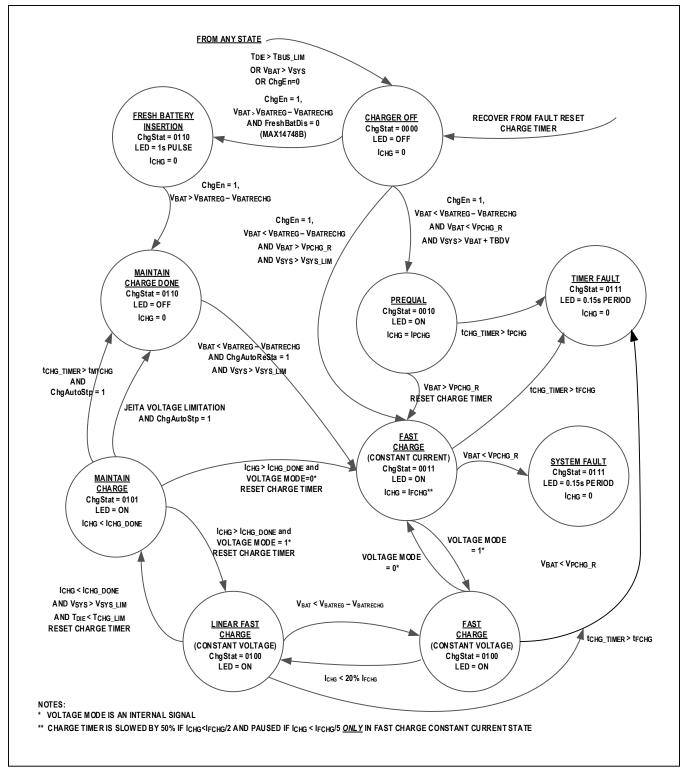


Figure 4. Battery Charger State Diagram

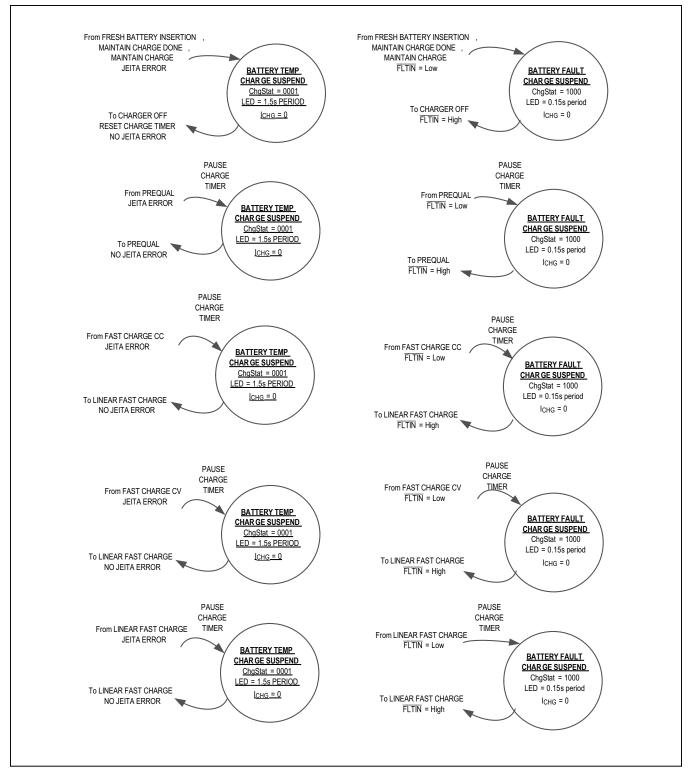


Figure 5. Battery Charger State Diagram (continued)

Li-ion Battery Charger

Charger Overview

The MAX14748 utilizes a boost converter to generate the necessary voltage to charge a 2s Li-ion battery from a nominal 5V USB charger input. Depending on the charging phase, the boost converter will operate as either a current-limited voltage source or current source. The charger is configured through a combination of external components and I²C registers settings. See Figure 4 and Figure 5 for the Battery Charger State Diagram. Note, for MAX14748, do not remove the battery while the charger is enabled (ChgEn=1).

Precharge

In precharge and charge termination phases, the boost converter functions as a current-limited voltage source and regulates V_{SYS} to V_{PCHG} +400mV. The battery is charged through an internal linear charging path with a maximum precharge current of 500mA (subject to thermal limitations), programmable through I²C. The precharge/fast-charge thresholds can be configured through register 0x1E and may not be less than the V_{OVP} (max).

Fast Charge

In the fast-charge phase, the boost converter functions as a current source delivering current into the SYS node. The SYS and BAT nodes are shorted together through the BAT-SYS FET, with a nominal resistance of $13m\Omega$ (typ). The fast-charge current is set by an external resistor, but may be modified by the T_T_IFchg[2:0] bits in registers 0x1A and 0x1B. The fast-charge current resistor can be calculated as $R_{\rm SET}$ = $K_{\rm SET}/I_{\rm FCHG}$, where $K_{\rm SET}$ has a typical value of 10000A/A. The range of acceptable resistors for $R_{\rm SET}$ is $3.3k\Omega$ to $100k\Omega$.

Charge Termination

During the charge termination phase, the battery current is monitored across the BAT-SYS FET. To prevent a 'false' termination of charge, the charge done condition is qualified by the state of the input current limit; if the input

current limit is currently active, the charge done condition is not triggered. The charge done condition is also debounced for 140µs in order to prevent transient system currents from triggering an incorrect done condition.

Thermistor Monitoring

The MAX14748 provides highly programmable thermal/JEITA charge management. All thermal/JEITA charge configuration parameters are set via the ThermCfg registers 0x1A - 0x1C. The charger is managed by thermal information only if JEITACtrSet = 1.

The battery pack temperature is measured from a divider formed by a pull-up resistor, an optional parallel resistor, and the battery pack thermistor. When required, the pullup resistor is connected to an internal supply through the TPU input, and the voltage on the THM pin is compared to an internal threshold. The supply voltage for the divider is applied to the V_{TPU} pin and may be connected to an external supply or to V_{CCINT}. The pullup resistor may be complemented with an additional parallel resistor to allow matching to different thermistor nominal values and charging cutoff temperatures, T1, T2, T3, and T4. There are two sets of cutoff temperatures optimized for a thermistor with Beta = 3380 (0°C/10°C/45°C/60°C or 0°C/10°C/25°C/45°C) which can be selected as factory default options. These cutoff temperatures divide the temperature range into three zones, T1_T2, T2_T3, and T3_T4. The charger is always turned off at temperatures outside these zones when any thermal monitoring mode is enabled. If the system needs to measure the THM temperature when not charging, the internal pullup switch may be enabled via the JeitaCfqR[1:0] bits.

Charging may be optionally disabled in the T1_T2 and T3_T4 zones through the T_T_EnSet bits. The charge current in each zone may be modified through T_T_IFchg[2:0]. Battery-voltage termination reduction may also be selectively applied through the T_T_VFset bits. See Figure 6 for more details.

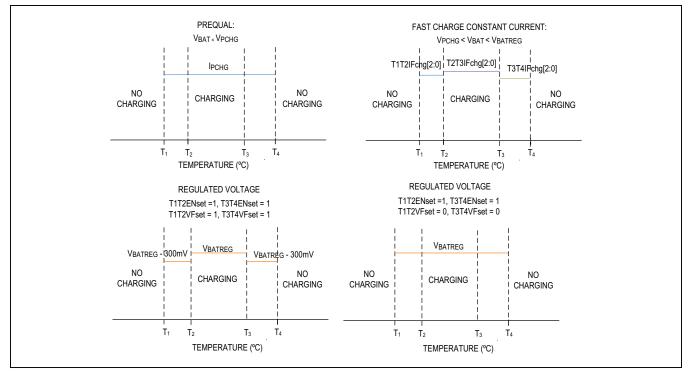


Figure 6. Thermistor Monitoring

Weak Battery Operation

The MAX14748 supports the weak battery provision of the USB 2.0 specification. If an SDP adapter is detected and the battery voltage is less than the precharge threshold, the input current limit is set to 500mA and a 2-minute timer starts. After the 2-minute timer expires, the input current limit is set to zero. Any time during the 2-minute countdown, the system may turn off the weak battery state machine and assert control of the input current limit by setting WeakBatEn to 0.

Battery Detection

The MAX14748 offers battery detection by detecting the presence of the battery thermistor. If the thermistor is not present, THM is pulled high by the external pullup resistor, and BatDet is set to 0 indicating that the battery is not connected.

Integrated USB 2.0 Analog Switch

A high-speed USB switch is integrated to provide the host data access to the connected USB device when an SDP or CDP port is detected. The analog switch may be controlled manually or automatically by configuring the AnSwCntl[1:0] bits in register 0x2F. When the analog switch control is set to the auto control setting then

the CDN/CDP pins are connected to TDN/TDP only when a SDP or CDP port is detected. (See <u>I2C Register</u> <u>Descriptions</u> for further details.)

SFOUT LDO

The SFOUT LDO is powered directly from the CHGIN input and may be used to power a USB transceiver, or as an indicator signal that a SDP/CDP port is present. The LDO will operate with CHGIN voltages greater than VBDET. The output voltage of SFOUT is selectable as either 5V or 3.3V through the SfOutLvI bit, depending on the system preference. SFOUT may be programmed to turn on automatically when an SDP or CDP is detected, or placed in manual mode and turned on through an I²C command. This supply is always available when CHGIN is present.

Internal Supplies and Regulators

The MAX14748 has two internal power supplies: V_{CCINT} and BREG. V_{CCINT} and BREG are always present when CHGIN or BAT is present. These supplies share a common source, but bypassed separately. The V_{CCINT} and BREG supplies require external bypass capacitors and are regulated to a nominal value of 4.3V (typ).

Device Control Interface

While the MAX14748 is primarily controlled by I²C, GPIO control is also offered for specific functions. The following GPIO control signals are provided (note that these signals only apply when CHGIN is present):

- FSUS (Input): Force Suspend. This pin enables the host microcontroller to force the input current limit to zero. When CHGIN is present, a logic-high on the pin causes the input OVP FET at CHGIN to open and the input current to MAX14748 is reduced to less than 2mA. This pin has no effect if FSUSMsk = 1.
- FLTIN (Input): Battery Fault Input. This pin allows the system or battery pack to place the charger into a fault condition using a GPIO pin. See Register 0x35 description for more details.
- 3) CDIR (Open-Drain Output): USB Superspeed MUX control. In USB Type-C plug configurations, it is necessary to detect the orientation of the connector and route the Superspeed lines accordingly. The pin can be used to automatically configure a USB Superspeed MUX according to the orientation information contained in the integrated Type-C detection block. (This information is also available through I²C) The

- CDIR output is pulled to GND when the CC1 pin is active on the Type-C connector, otherwise it is high-impedance.
- 4) SYSOK (Open-Drain Output): With CHGIN present, the SYSOK output is asserted if the boost regulator generates a V_{SYS} greater than SYS UVLO threshold, V_{SYSUVLO}. Otherwise, the output is high-impedance. This pin can be used as wake up the host system from a dead-battery. Note that when V_{SYS} falls below the SYS UVLO falling threshold, the input OVP switch is opened as the boost converter cannot operate in this state.
- 5) BVCEN (Open-Drain Output): When CHGIN is present and a Type-C device that requires V_{CONN} is found, this pin is asserted. This pin should be connected to the enable pin of the V_{CONN} power supply enable. The output of BVCEN is push-pull between GND and V_{CCINT}.

System Faults

The MAX14748 monitors the system for faults including OVP Soft Start Timeout, SYS UVLO, Direct Charging Fault, Charger Tlmeout, Forced Charger Fault, Dead Battery, CHGIN OVP. See Table 1bb for more details.

Table 1b. System Faults Summary

FAULT NAME	EFFECT	CAUSE DESCRIPTION	HOW TO RECOVER	STAUS BIT
OVP Soft-Start TimeOut	System Fault Condition Latched. OVP/Boost/Charger Off	UFP: V _{BYP} is not within 50mV of V _{CHGIN} at Soft Start TimeOut (100ms typ)	Unplug/Replug Type-C cable or reset device via USBCRSet of Reg 0x30	SysFit (Reg 0x02)
SYS UVLO	System Fault Condition Latched. OVP/Boost/Charger Off	UFP: V _{SYS} falls below SYS UVLO threshold while in Boost mode or V _{SYS} fails to reach above SYS UVLO threshold within 20ms after V _{BYP} rises	Unplug/Replug Type-C cable or resert device via USBCRSet of Reg 0x30	SysFlt (Reg 0x02)
Direct Charging Fault	Charger Fault Condition Latched. Charger Off	UFP: V _{BAT} falls below V _{PCHG} while in Fast Charge mode	Cycle ChgEn or treat as System Fault	DirChgFault (Reg 0x05)
Charger Timeout	Charger Fault Condition Latched. Charger Off	UFP: Pre-charge or Fast- charge Timer expires	Cycle ChgEn or treat as System Fault	ChgStat[3:0] (Reg 0x05)
Forced Charger Fault	Charger Off	UFP: Logic-low applied on FLTIN pin	Logic-high applied on FLTIN pin	ChgStat[3:0] (Reg 0x05)
Dead Battery	System Fault Condition Latched. OVP/Boost/Charger Off	UFP: DeadBattery detection enabled and SDP detected: V _{BAT} fails to reach above V _{PCHG} within 2min	Treat as System Fault or disable DeadBattery	WbChg (Reg 0x02)
CHGIN OVP	OVP/Boost/Charger OFF	V _{CHGIN} rises above V _{OVP}	Reduce V _{CHGIN} below V _{OVP_F}	ChginOVP (Reg 0x02)

I²C Interface

The MAX14748 contain an I²C-compatible interface for data communication with a host controller (SCL and SDA). The interface supports a clock frequency of up to 400kHz. SCL and SDA require pullup resistors that are connected to a positive supply.

Start, Stop, And Repeated Start Conditions

When writing to the MAX14748 using I²C, the master sends a START condition (S) followed by the MAX14748 I²C address. After the address, the master sends the register address of the register that is to be programmed. The master then ends communication by issuing a STOP condition (P) to relinquish control of the bus, or a REPEATED START condition (Sr) to communicate to another I²C slave. See Figure 7.

Table 2. I2C Slave Addresses

ADDRESS FORMAT	HEX	BINARY
7-Bit Slave ID	0x0A	0001010
Write Address	0x14	00010100
Read Address	0x15	00010101

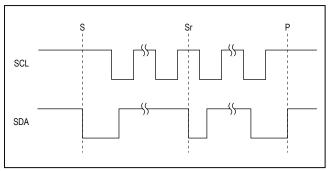


Figure 7. I²C START, STOP and REPEATED START Conditions

Slave Address

Set the Read/Write bit high to configure the MAX14748 to read mode (Table 2). Set the Read/Write bit low to configure the MAX14748 to write mode. The address is the first byte of information sent to the MAX14748 after the START condition.

Bit Transfer

One data bit is transferred on the rising edge of each SCL clock cycle. The data on SDA must remain stable during the high period of the SCL clock pulse. Changes in SDA while SCL is high and stable are considered control signals (see the <u>Start, Stop, And Repeated Start Conditions</u> section). Both SDA and SCL remain high when the bus is not active.

Single-Byte Write

In this operation, the master sends an address and two data bytes to the slave device (Figure 8). The following procedure describes the single byte write operation:

- 1) The master sends a START condition
- 2) The master sends the 7-bit slave address plus a write bit (low)
- 3) The addressed slave asserts an ACK on the data line
- 4) The master sends the 8-bit register address
- The slave asserts an ACK on the data line only if the address is valid (NAK if not)
- 6) The master sends 8 data bits
- 7) The slave asserts an ACK on the data line
- 8) The master generates a STOP condition

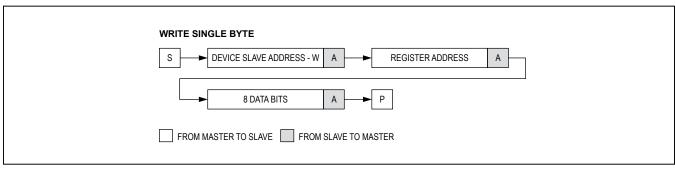


Figure 8. Write Byte Sequence

Burst Write

In this operation, the master sends an address and multiple data bytes to the slave device (Figure 9). The slave device automatically increments the register address after each data byte is sent. The following procedure describes the burst write operation:

- 1) The master sends a START condition.
- 2) The master sends the 7-bit slave address plus a write bit (low).
- 3) The addressed slave asserts an ACK on the data line.
- 4) The master sends the 8-bit register address.
- 5) The slave asserts an ACK on the data line only if the address is valid (NAK if not).
- 6) The master sends eight data bits.
- 7) The slave asserts an ACK on the data line.
- 8) Repeat 6 and 7 N-1 times.
- 9) The master generates a STOP condition.

Single-Byte Read

In this operation, the master sends an address plus two data bytes and receives one data byte from the slave device (Figure 10). The following procedure describes the single byte read operation:

- 1) The master sends a START condition.
- The master sends the 7-bit slave address plus a write bit (low).
- 3) The addressed slave asserts an ACK on the data line.
- 4) The master sends the 8-bit register address.
- 5) The slave asserts an ACK on the data line only if the address is valid (NAK if not).
- 6) The master sends a REPEATED START condition.
- 7) The master sends the 7-bit slave address plus a read bit (high).
- 8) The addressed slave asserts an ACK on the data line.
- 9) The slave sends eight data bits.
- 10) The master asserts a NACK on the data line.
- 11) The master generates a STOP condition.

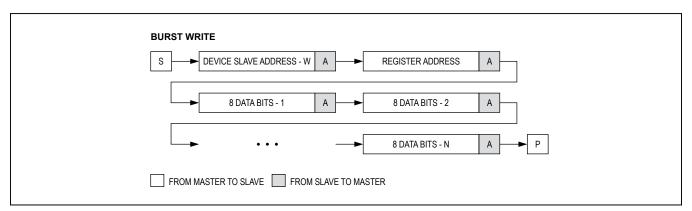


Figure 9. Burst Write Sequence

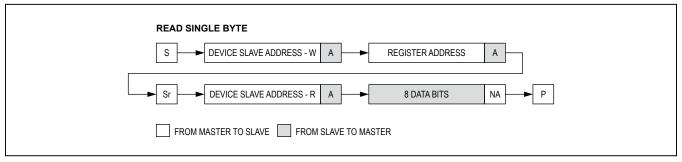


Figure 10. Read Byte Sequence

Burst Read

In this operation, the master sends an address plus two data bytes and receives multiple data bytes from the slave device (Figure 11). The following procedure describes the burst byte read operation:

- 1) The master sends a START condition.
- The master sends the 7-bit slave address plus a write bit (low).
- 3) The addressed slave asserts an ACK on the data line.
- 4) The master sends the 8-bit register address.
- 5) The slave asserts an ACK on the data line only if the address is valid (NAK if not).
- 6) The master sends a REPEATED START condition.
- 7) The master sends the 7-bit slave address plus a read bit (high).
- 8) The slave asserts an ACK on the data line.

- 9) The slave sends eight data bits.
- 10) The master asserts an ACK on the data line.
- 11) Repeat 9 and 10 N-2 times.
- 12) The slave sends the last eight data bits.
- 13) The master asserts a NACK on the data line.
- 14) The master generates a STOP condition.

Acknowledge Bits

Data transfers are acknowledged with an acknowledge bit (ACK) or a not-acknowledge bit (NACK). Both the master and the MAX14748 generate ACK bits. To generate an ACK, pull SDA low before the rising edge of the ninth clock pulse and hold it low during the high period of the ninth clock pulse (see Figure 12). To generate a NACK, leave SDA high before the rising edge of the ninth clock pulse and leave it high for the duration of the ninth clock pulse. Monitoring for NACK bits allows for detection of unsuccessful data transfers.

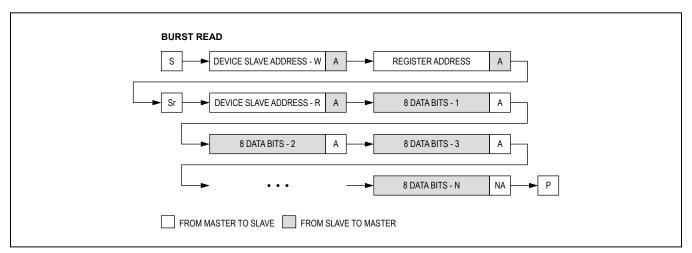


Figure 11. Burst Read Sequence

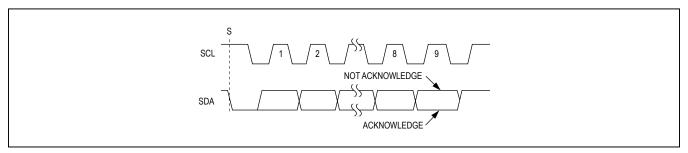


Figure 12. Acknowledge

Table 3. I2C Register Map

	ADDRESS NAME		i	90	ŝ	5	3	4	i	90
0x00	ChipID	ď				Ch	ChipId[7:0]			
0x01	ChipRev	œ		Chip	ChipRevH[3:0]			ChipR	ChipRevL[3:0]	
0x02	DevStatus1	œ	SysFlt	ChgInOVP	lLim	VSysReg	ThrmSd150	ThrmSd120	BatDet	WbChg
0x03	AICLStatus	œ		AICLStatus[2:0]			4	AICLCurSet[4:0]		
0x04	DevStatus2	œ	ı	BattPREQB	ı	BypUVLO	SysUVLOB	DCDCILim	DCDCRunAway	DCDCPGood
0x05	ChgStatus	œ	DirChgFault	1	LowPow	ı		ChgS	ChgStat[3:0]	
90×0	JEITAStatus	Я	-	-	I	ChgThrmRegCur	ChgThrmRegVlt		ChgThrmStat[2:0]	
0x07	BCStatus	œ	VBUSDet	ChgTypRun		PrChgTyp[2:0]		DCDTmo	ChgTyp[1:0]	[1:0]
0×08	Reserved	œ	ı	1	1	I	I	1	I	ı
60×0	CCStatus1	æ	CCPin8	CCPinStat[1:0]	IDD	CCIStat[1:0]	CCVcnStat		CCStat[2:0]	
0x0A	CCStatus2	œ	ı	ı	ı	I	VSAFEOV	DetAbrt	ı	ı
0x0B	DevInt1	COR	SysFiti	ChglnOVPI	lLiml	VSysRegI	ThrmSd1501	ThrmSd1201	BatDetl	WbChgl
0x0C	AICLInt	COR	ı	AICLI	ı	I	I	ı	I	ı
0x0D	DevInt2	COR	ı	BattPREQi	1	BypUVLOI	SysUVLOI	1	I	DCDCPGoodl
0x0E	ChgInt	COR	DirChgFaultl	LowPowRI	LowPowFl	I	1	ı	I	ChgStatl
0x0F	JEITAInt	COR	ı	-	ı	ChgThrmRegCurl	ChgThrmRegVItI	ı	I	ChgThrmStatl
0x10	BCInt	COR	VBUSDetl	-	I	ChgTypRunFl	ChgTypRunRl	PrChgTypl	DCDTmol	ChgTypl
0x11	CCInt	COR	1	VSAFE0VI	DetAbrtl		CCPinStatl	CCIStatl	CCVcnStatl	CCStatl
0x12	DevInt1Mask	R/W	SysFitIM	ChgInOVPIM	ILimIM	VSysRegIM	ThrmSd150IM	ThrmSd120IM	BatDetIM	WbChgIM
0x13	AICLIntMask	R/W	ı	AICLIM	1	ı	1	I	ı	ı
0x14	DevInt2Mask	R/W	1	BattPREQIM	1	BypUVLOIM	SysUVLOIM	DCDCILimIM	DCDCRunAwayIM	DCDCPGoodIM
0x15	ChglntMask	R/W	DirChgFaultlM	LowPowRIM	LowPowFIM	ı	1	ı	ı	ChgStatIM
0x16	JEITAIntMask	R/W	ı	ı	I	ChgThrmReg CurIM	ChgThrmReg VItIM	I	I	ChgThrmStatIM
0x17	BCIntMask	R/W	VBUSDetIM	I	I	ChgTypRunFIM	ChgTypRunRIM	PrChgTypIM	DCDTmolM	ChgTypIM
0x18	CCIntMask	R/W	1	VSAFE0VIM	DetAbrtIM	1	CCPinStatIM	CCIStatIM	CCVcnStatIM	CCStatIM
0x19	LED_CTRL	R/W	1	I	1	I	-	1	LEDCtrl	LEDManual
0x1A	ThermaCfg1	R/W		T1T2IFchg[2:0]			T2T3IFchg[2:0]		JeitaCfgR[1:0]	R[1:0]
0x1B	ThermaCfg2	R/W		T3T4IFchg[2:0]		I	T3T4ENset	T1T2ENset	T3T4VFset	T1T2VFset
0x1C	ThermaCfg3	R/W	_	1	1	1	1	1	JEITACtrSet	WarmCoolSel*
0×1D	ChargerCtrl1	R/W**	ChgAutoStp	BatReChg[1:0]	:hg[1:0]	FreshBatDis (MAX14748B)	ı	Bati	BatReg[1:0]	ChgEn
0x1E	ChargerCtrl2	R/W*	I		VPchg[2:0]		IPChg[1:0]	1:0]	ChgDone[1:0]	ie[1:0]

Table 3. I2C Register Map (continued)

REGISTER ADDRESS	REGISTER NAME	R/W	B7	B6	B5	B4	B3	B2	B1	B0
0x1F	ChargerCtrl3	R/W**	ı	ChgAutoSta	MtCh	MtChgTmr[1:0]	FChgTmr[1:0]	ır[1:0]	PChgTmr[1:0]	mr[1:0]
0x20	ChargerCtrl4	R/W*		WeakBatStat[2:0]*	*	I	ı	WeakBatEn	I	I
0x21	CurLimCtrl	R/W	CurLim1Frc	FSUSMsk				CurLim1Set[4:0]		
0x22	CurLimStatus	٣		CurLim2Rb[2:0]			S	SpvChglLim[4:0]		
0x23	BBCFG1	R/W*		Boost	BoostRComp[3:0]		1	ı	1	ı
0x24	BBCFG2	R/W*	ı	I	ı	BBFrcZX		BuckV	BuckVSet[3:0]	
0x25	BCCtrl1	RW	DCD2s	SfOutLvI	ı	ADC3PDet	SfOutCtrl[1:0]	1[1:0]	ChgDetMan	ChgDetEn
0x26	Reserved	œ	1	ı	ı	ı	ı	ı	ı	ı
0x27	CCCtrl1	RW	ı	I	ı	CCSrcSnk	CCSnkSrc	CCDbgEn	CCAudEn	CCDetEn
0x28	CCCtrl2	R/W	CCForceError	SnkAttached Lock	CCSnkSrcSwp	CCSrcSnkSwp	CCVcnSwp	CCVcnEn	CCSrcRst	CCSnkRst
0x29	CCCtrl3	R/W	I	-	ı	I	CCTrySnk	CCPreferSnk	CCDRPPhase[1] CCDRPPhase[0]	^o hase[1] ^o hase[0]
0x2A	CHGINILim1	œ	ı				CHGINILim[6:0]			
0x2B	CHGINILim2	R/W	ı	-	I	ı	CHGINILimGate	SDPM	SDPMaxCur[1:0]	CDPMaxCur
0x2C	AICLCFG1	R/W	AICLEn	_	ı	-	ı			AICLAbort
0x2D	AICLCFG2	R/W		BYPUVLO[2:0]				AICLMaxl[4:0]		
0x2E	AICLCFG3	R/W	-	-	-	ВҮРDеb	AICLTBIK[1:0]	(1:0]	AICLTStep[1:0]	ep[1:0]
0x2F	DPDNSw	R/W	•	-	-	-	-	•	AnSwCntl[1:0]	ntl[1:0]
0x30	Others	R/W	•	-			-	•	•	USBCRset
0x31	Reserved	&	•	-		•	ı	•	•	•
0x32	Reserved	æ	,	•	-	•	1		•	
0x33	LowPow	R/W	LowPowEn	•		'	1	,	•	LowPowAbort
0x34	Reserved	ж	•	•		•	-	•	-	-
0x35	FLTSel	R/W	FLTSel	FLTSelect[1:0]	-	-	-	-		-
	-	'								

Note:

COR = Clear-on-read
* Read Only
** Read Only if WriteProtect is enabled (See Table 61).
Reserved bits must not be modified from their default states to ensure proper operation.

I²C Register Descriptions

Table 4. ChipID Register (0x00)

ADDRESS:	0x00							
MODE:	Read Only							
BIT	7	6	5	4	3	2	1	0
NAME				Chipl	d[7:0]			
ChipId[7:0]	ChipId[7:0] bi	ts show inforn	nation about th	e version of th	e MAX14748.			

Table 5. ChipRev Register (0x01)

ADDRESS:	0x01									
MODE:	Read Only									
BIT	7	6	5	4	3	2	1	0		
NAME		ChipRe	evH[3:0]			ChipRe	evL[3:0]			
ChipRevH[3:0]	ChipRevH[3:0)] bits show in	formation abo	ut the revision	of the MAX147	48 silicon.				
ChipRevL[3:0]	ChipRevL[3:0	ChipRevL[3:0] bits show information about the revision of the MAX14748 silicon.								

Table 6. DevStatus1 Register (0x02)

ADDRESS:	0x02									
MODE:	Read Only									
BIT	7	6	5	4	3	2	1	0		
NAME	SysFlt	ChgInOVP	lLim	VSysReg	ThrmSd150	ThrmSd120	BatDet	WbChg		
SysFlt	0 = System v	System Fault 0 = System voltage is normal 1 = SYS voltage below SYS UVLO Threshold and the condition latched.								
ChglnOVP	0 = CHGIN C	CHGIN Overvoltage Protection Flag 0 = CHGIN OVP not active 1 = CHGIN OVP active								
lLim	0 = CHGIN in	Input Current Limiting 0 = CHGIN input current within limit 1 = CHGIN input in current limit								
VSysReg	0 = SYS volt	tion (SYSOK) age above SYS age below SYS								
ThrmSd150		tdown n normal operat n thermal shutd		150°C)						
ThrmSd120		rm n normal operat T _{DIE} < 150°C	ion Mode							
BatDet	Status of Battery Detection 0 = No battery detected 1 = Battery detected									
WbChg		y Charging attery Charge T attery Charge T	•	or not running						

Table 7. AICLStatus Register (0x03)

ADDRESS:	0x03											
MODE:	Read Only											
BIT	7	7 6 5 4 3 2 1 0										
NAME	l l	AICLStatus[2:0] AICLCurSet[4:0]										
AICLStatus[2:0]	001 = AICL F 010 = AICL II 011 = AICL B 100 = AICL I	AICL Status 000 = AICL Off 001 = AICL Precheck 010 = AICL Increment 011 = AICL Blank 100 = AICL Idle 101 = AICL No Connection										
AICLCurSet[4:0]	Current limit 0 = 100mA 1 = 200mA 30 = 3.1A 31 = 3.2A	set by AICL (i	f active)									

Table 8. DevStatus2 Register (0x04)

ADDRESS:	0x04							
MODE:	Read	Only						
BIT	7	6	5	4	3	2	1	0
NAME	-	BattPREQB	-	BypUVLO	SysUVLOB	DCDCILim	DCDCRunAway	DCDCPGood
BattPREQB	Battery 0 = V _B	vs. V _{PCHG} (V _{PC} y 2min timer is i _{BAT} below V _{PCH} _{BAT} above V _{PCH}	running.) IG threshold	nable from 5.7	V to 6.4V, Bat	tPreqB status	is NOT valid while t	he Weak
BypUVLO	0 = V _B	vs. V _{BYPUVLO} (_{BYP} above V _{BYF} _{BYP} below V _{BYF}	OUVLO theshol	d	from 3.8V to 4.	5V)		
SysUVLOB	mode v	V _{SYS} vs. V _{SYSUVLO} (V _{SYSUVLO} programmable from 6.1V to 6.8V, SysUVLOB status is only valid in boost mode with CHGIN present)) $0 = V_{SYS} \text{ below } V_{SYSUVLO} \text{ threshold}$ $1 = V_{SYS} \text{ above } V_{SYSUVLO} \text{ threshold}$						
DCDCILim	0 = No	se Buck Convelormal Operation						
DCDCRunAway	0 = No	se Buck Conver ormal Operation lick runaway is a	_	Status				
DCDCPGood	0 = Bu	se Buck Conve lick regulated va ormal operation	U		t value			

Table 9. ChgStatus Register (0x05)

ADDRESS:	0x05							
MODE:	Read Only							
BIT	7	6	5	4	3	2	1	0
NAME	DirChgFault	-	LowPow	-	Stat[3:0]			
DirChgFault	Direct charging f 0 = Device in no 1 = V _{BAT} drops l	rmal operation		y is in supp	plement mode) .		
LowPow	Low Power Mod 0 = Not In Low F 1 = In Low Powe	ower Mode						
ChgStat[3:0]	Status of Charge 0000 = Charger 0001 = Charging 0010 = Pre-char 0011 = Fast-cha 0100 = Fast-cha 0101 = Maintain 0110 = Maintain 0111 = Charger i 1000 = Battery F	off g suspended ge in progres rge, constan rge, constan charge in pr charge done fault conditio	ss t current mod t voltage mod ogress n (see state c	e in progre le in progre liagram)	ss	n)		

Table 10. JEITAStatus Register (0x06)

ADDRESS:	0x06									
MODE:	Read On	nly								
BIT	7	6	5	4	3	2	1	0		
NAME	-	-	-	ChgThrmRegCur	ChgThrmRegVlt	egVlt ChgThrmStat[2:0]				
ChgThrmRegCur	FastChar 0 = Not o 1 = Redu	hanged	it reduced	due to JEITA status						
ChgThrmRegVIt	Battery F 0 = Not 0 1 = Redu	Changed	Voltage re	educed due to JEITA sta	atus					
ChgThrmStat[2:0]	000 = T < 001 = T1 010 = T2 011 = T3 100 = T > 101 = No thermistor 110 = NT	< T < T2 < T < T3 < T < T4 > T4 o thermistor or monitori C input di	r detected ng, this mo sabled thr	I (THM high due to exte ode may not function pr ough ThermEn. to CHGIN not present.	operly.	parallel res	istor is used	for		

Table 11. BCStatus Register (0x07)

ADDRESS:	0x09							
MODE:	Read Only							
BIT	7	6	5	4	3	2	1	0
NAME	VBUSDet	ChgTypRun		PrChgTyp[2	0]	DCDTmo	ChgT	yp[1:0]
VBUSDet	Status of CHO 0 = VCHGIN < 1 = VCHGIN >							
ChgTypRun	Charger Dete 0 = Not Runn 1 = Running	ection Running S ing	tatus					
PrChgTyp[2:0]	Output of Pro 000 = Unknow 001 = Samsu 010 = Apple 0 011 = Apple 1 100 = Apple 2 101 = Apple 1 110 = 3A DCF 111 = RFU	ng 2A 0.5A IA 2A 12W	Detection					
DCDTmo	continues as	required by BC1 out or detection n	.2, but SDP			ndicating D+/D- ar	e open. BC1	.2 detection
ChgTyp[1:0]	00 = Nothing 01 = SDP, US 10 = CDP, Ch	arger Detection attached 6B Cable attache arging Downstre dicated Charger	eam Port (cı		s on USB op	erating speed)		

Table 12. Reserved Register (0x08)

ADDRESS:	0x08							
MODE:	Read Only							
BIT	7	6	5	4	3	2	1	0
NAME	-	-	-	-	-	-	-	-

Table 13. CCStatus1 Register (0x09)

ADDRESS:	0x09							
MODE:	Read Only							
BIT	7	6	5	4	3	2	1	0
NAME	CCPins	Stat[1:0]	CC	SIStat	CCVcnStat		CCStat[2:0]	
CCPinStat[1:0]	Status of Act 00 = No Dete 01 = CC1 Ac 10 = CC2 Ac 11 = RFU	ermination tive						
CCIStat	CC Pin Dete 00 = Not in U 01 = 500mA 10 = 1.5A 11 = 3.0A		BUS Current	in UFP mode				
CCVcnStat	Status of VC 0 = VCONN 1 = VCONN	Disabled						
CCStat[2:0]	Output of CC 000 = No Co 001 = UFP 010 = DFP 011 = Audio of 100 = Debug 101 = Error 110 = Disable 111 = RFU	Accessory J Accessory	State Machir	ne				

Table 14. CCStatus2 Register (0x0A)

ADDRESS:	0x0A										
MODE:	Read Only										
BIT	7	6	5	4	3	2	1	0			
NAME	-	-	-	-	VSAFE0V	DetAbrt	-	-			
VSAFE0V	Status of VB 0 = V _{CHGIN} · 1 = V _{CHGIN} ·	< VSAFE0V	(Valid only in A	Attached.SRC_	_CCx, Attached	I.SNK_CCx sta	ite)				
DetAbrt	1 = Charger VBUS is valid	Detection runs Detection is at d for the debou	oorted by Type unce time. Chg	-C State Mach DetMan bit all	is valid for the nine. Charger do ows manual ru the in-progress	etection will rur n of charger de	n if ChgDetEn				

Table 15. DevInt1 Register (0x0B)

ADDRESS:	0x0B									
MODE:	Clear On Rea	d								
BIT	7	6	5	4	3	2	1	0		
NAME	SysFltI	ChglnOVPI	lLiml	VSysRegI	ThrmSd150I	ThrmSd120I	BatDetl	WbChgI		
SysFiti	0 = Status of S	SysFlt status change interrupt. 0 = Status of SysFlt has NOT changed since the last time SysFltI was read 1 = Status of SysFlt has changed since the last time SysFltI was read								
ChglnOVPI	0 = Status of C	hgInOVP status change interrupt. = Status of ChgInOVP has NOT changed since the last time ChgInOVPI was read = Status of ChgInOVP has changed since the last time ChgInOVPI was read								
ILimI	0 = Status of I	Lim status change interrupt. = Status of ILim has NOT changed since the last time ILimI was read = Status of ILim has changed since the last time ILimI was read								
VSysRegI	0 = Status of \		OT changed		me VSysRegI wa SysRegI was read					
ThrmSd150I	0 = Status of T		NOT change		time ThrmSd150 ThrmSd150I was					
ThrmSd120I	0 = Status of T		NOT change		time ThrmSd120 ThrmSd120I was					
BatDetI	0 = Status of E	BatDet status change interrupt. 0 = Status of BatDet has NOT changed since the last time BatDetI was read 1 = Status of BatDet has changed since the last time BatDetI was read								
WbChgl	0 = Status of V	change interru VbChg has NO VbChg has cha	T changed sir		e WbChgl was re Chgl was read	ad				

Table 16. AICLInt Register (0x0C)

ADDRESS:	0x0C										
MODE:	Clear On Re	Clear On Read									
BIT	7	6	5	4	3	2	1	0			
NAME	-	AICLI	-	-	-	-	-	-			
AICLI	0 = Status of		s NOT change		et time AICLI wa AICLI was rea						

Table 17. DevInt2 Register (0x0D)

ADDRESS:	0x0D									
MODE:	Clear On Re	ad								
BIT	7	6	5	4	3	2	1	0		
NAME	_	BattPREQI	_	BypUVLOI	SysUVLOI	DCDCILimI	DCDCRunAwayl	DCDCPGoodI		
BattPREQI	0 = Status of	lattPREQ status change interrupt. = Status of BattPREQ has NOT changed since the last time BattPREQI was read = Status of BattPREQ has changed since the last time BattPREQI was read								
BypUVLOI	0 = Status of	ypUVLO status change interrupt. = Status of BypUVLO has NOT changed since the last time BypUVLOI was read = Status of BypUVLO has changed since the last time BypUVLOI was read								
SysUVLOI	0 = Status of	atus change int SysUVLO has SysUVLO has	NOT chang		-		ead			
DCDCILimI	0 = Status of	atus change in DCDCILim ha DCDCILim ha	s NOT chan				read			
DCDCRunAwayI	0 = Status of	DCDCRunAway status change interrupt. D = Status of DCDCRunAway has NOT changed since the last time DCDCRunAway was read 1 = Status of DCDCRunAway has changed since the last time DCDCRunAway was read								
DCDCPGoodl	0 = Status of	d status change DCDCPGood DCDCPGood	has NOT ch							

Table 18. Chglnt Register (0x0E)

ADDRESS:	0x0E											
MODE:	Clear On Read											
BIT	7	6	5	4	3	2	1	0				
NAME	DirChgFaultl	DirChgFaultI LowPowRI LowPowFI ChgS										
DirChgFaultI	0 = Status of DirCho	DirChgFault status change interrupt. In Status of DirChgFault has NOT changed since the last time DirChgFaultI was read In Status of DirChgFault has changed since the last time DirChgFaultI was read										
LowPowRI	0 = LowPow bit rise	LowPow Rising Edge interrupt. 0 = LowPow bit rise edge has NOT occurred since the last time LowPowRI was read 1 = LowPow bit rise edge has occurred since the last time LowPowRI was read										
LowPowFl	LowPow Falling Edg 0 = LowPow bit fallin 1 = LowPow bit fallin	ng edge has NO										
ChgStatI	ChgStat[3:0] status 0 = Status of ChgSt 1 = Status of ChgSt	at[3:0] has NOT	changed since the		J							

Table 19. JEITAInt Register (0x0F)

ADDRESS:	0x0	0x0F										
MODE:	Clea	Clear On Read										
BIT	7	6	5	4	3	2	1	0				
NAME	-	ChgThrmRegCurl ChgThrmRegVltl ChgThrm										
ChgThrmRegCurl	0 = 8	ChgThrmRegCur status change interrupt. D = Status of ChgThrmRegCur has NOT changed since the last time ChgThrmRegCurl was read 1 = Status of ChgThrmRegCur has changed since the last time ChgThrmRegCurl was read										
ChgThrmRegVItI	0 = 8	ChgThrmRegVlt status change interrupt. = Status of ChgThrmRegVlt has NOT changed since the last time ChgThrmRegVltI was read = Status of ChgThrmRegVlt has changed since the last time ChgThrmRegVltI was read										
ChgThrmStatl	0 = 8	Status of C	hgThrmSta	change interrupt. at[2:0] has NOT changed at[2:0] has changed since	_							

Table 20. BCInt Register (0x10)

ADDRESS:	0x10								
MODE:	Clear On R	ead							
BIT	7	6	5	4	3	2	1	0	
NAME	VBUSDetI	-	-	ChgTypRunFI	ChgTypRunRI	PrChgTypl	DCDTmol	ChgTypl	
VBUSDetl	0 = Status o	/BUSDet status change interrupt.) = Status of VBUSDet has NOT changed since the last time VBUSDetI was read = Status of VBUSDet has changed since the last time VBUSDetI was read							
ChgTypRunFl	0 = ChgTyp	ChgTypRun Falling Edge interrupt. D = ChgTypRun bit falling edge has NOT occurred since the last time ChgTypRunFl was read 1 = ChgTypRun bit falling edge has occurred since the last time ChgTypRunFl was read							
ChgTypRunRI		Run bit ris	ing edge l	upt. has NOT occurred has occurred since					
PrChgTypl		of PrChgTy	p has NO	upt. T changed since the anged since the las	_				
DCDTmol	0 = Status o	DCDTmo status change interrupt. 0 = Status of DCDTmo has NOT changed since the last time DCDTmol was read 1 = Status of DCDTmo has changed since the last time DCDTmol was read							
ChgTypI	ChgTyp status change interrupt. 0 = Status of ChgTyp has NOT changed since the last time ChgTypl was read 1 = Status of ChgTyp has changed since the last time ChgTypl was read								

Table 21. CCInt Register (0x11)

ADDRESS:	0x11										
MODE:	Clear On Rea	d									
BIT	7	6	5	4	3	2	1	0			
NAME	-	VSAFE0VI	DetAbrtI	-	CCPinStatl	CCIStatl	CCVcnStatI	CCStatl			
VSAFE0VI	0 = Status of \	/SAFE0V status change interrupt.) = Status of VSAFE0V has NOT changed since the last time VSAFE0VI was read I = Status of VSAFE0V has changed since the last time VSAFE0VI was read									
DetAbrtl	0 = Status of E	etAbrt status change interrupt. = Status of DetAbrt has NOT changed since the last time DetAbrtl was read = Status of DetAbrt has changed since the last time DetAbrtl was read									
CCPinStatl	0 = Status of 0	CCPinStat status change interrupt. 0 = Status of CCPinStat has NOT changed since the last time CCPinStatl was read 1 = Status of CCPinStat has changed since the last time CCPinStatl was read									
CCIStatl	0 = Status of 0		T changed s	since the last tim							
CCVcnStatl	0 = Status of 0	CCVcnStat status change interrupt. 0 = Status of CCVcnStat has NOT changed since the last time CCVcnStatl was read 1 = Status of CCVcnStat has changed since the last time CCVcnStatl was read									
CCStatl	CCStat status change interrupt. 0 = Status of CCStat has NOT changed since the last time CCStatl was read 1 = Status of CCStat has changed since the last time CCStatl was read										

Table 22. DevInt1Mask Register (0x12)

ADDRESS:	0x12										
MODE:	Read/Write										
BIT	7	6	5	4	3	2	1	0			
NAME	SysFltIM	ChglnOVPIM	ILimIM	VSysRegIM	ThrmSd150IM	ThrmSd120IM	BatDetIM	WbChgIM			
SysFitIM	SysFltI Interru 1 = Mask 0 = Unmask										
ChglnOVPIM	ChglnOVPI In 1 = Mask 0 = Unmask										
ILimIM	ILiml Interrupt 1 = Mask 0 = Unmask	Mask									
VSysRegIM	VSysRegI Inte 1 = Mask 0 = Unmask	errupt Mask									
ThrmSd150IM	ThrmSd150I II 1 = Mask 0 = Unmask	nterrupt Mask									
ThrmSd120IM	ThrmSd120I I 1 = Mask 0 = Unmask	nterrupt Mask									
BatDetIM	BatDetl Interru 1 = Mask 0 = Unmask	upt Mask									
WbChgIM	WbChgl Interr 1 = Mask 0 = Unmask	rupt Mask									

Table 23. AICLIntMask Register (0x13)

ADDRESS:	0x13	0x13									
MODE:	Read/Write	Read/Write									
BIT	7	6	5	4	3	2	1	0			
NAME	-	AICLIM	-	-	-	-	-	-			
AICLIM	AICLI Interru 1 = Mask 0 = Unmask	pt Mask									

Table 24. DevInt2Mask Register (0x14)

ADDRESS:	0x14	x14											
MODE:	Read/V	Vrite											
BIT	7	6	5	4	3	2	1	0					
NAME	-	BattPREQIM	-	BypUVLOIM	SysUVLOIM	DCDCILimIM	DCDCRunAwayIM	DCDCPGoodIM					
BattPREQIM	1 = Ma	tPREQI Interrupt Mask Mask Unmask											
BypUVLOIM	1 = Ma	pUVLOI Interrupt Mask Mask Unmask											
SysUVLOIM	SysUVI 1 = Mas 0 = Unr		lask										
DCDCILimIM	DCDCI 1 = Mas 0 = Unr		Mask										
DCDCRunAwayIM	1 = Ma	DCDCRunAwayl Interrupt Mask = Mask = Unmask											
DCDCPGoodIM	DCDCF 1 = Mas 0 = Unr		pt Mask										

Table 25. ChglntMask Register (0x15)

ADDRESS:	0x15	0x15										
MODE:	Read/Write											
BIT	7	6	5	4	3	2	1	0				
NAME	DirChgFaultIM	LowPowRIM	LowPowFIM	-	-	-	-	ChgStatIM				
DirChgFaultI M	DirChgFaultI Intel 1 = Mask 0 = Unmask											
LowPowRIM	LowPowRI Interru 1 = Mask 0 = Unmask											
LowPowFIM	LowPowFl Interru 1 = Mask 0 = Unmask											
ChgStatIM	ChgStatl Interrup 1 = Mask 0 = Unmask	t Mask										

Table 26. JEITAIntMask Register (0x16)

ADDRESS:	0x16	0x16										
MODE:	Read/Wr	Read/Write										
BIT	7	7 6 5 4 3 2 1 0										
NAME	-	ChgThrmRegCurlM ChgThrmRegVltIM ChgThrmStatIM										
ChgThrmRegCurlM	1 = Mask	ChgThrmRegCurl Interrupt Mask 1 = Mask 0 = Unmask										
ChgThrmRegVitIM	1 = Mask	ChgTHrmRegVI Interrupt Mask = Mask = Unmask										
ChgThrmIM	ChgThrm 1 = Mask 0 = Unma		t Mask									

Table 27. BCIntMask Register (0x17)

ADDRESS:	0x17									
MODE:	Read/Write									
BIT	7	6	5	4	3	2	1	0		
NAME	VBUSDetIM	ı	1	ChgTypRunFIM	ChgTypRunRIM	PrChgTypIM	DCDTmolM	ChgTypIM		
VBUSDetIM	VBUSDetl Inter 1 = Mask 0 = Unmask									
ChgTypRunFIM	ChgTypRunFI I 1 = Mask 0 = Unmask									
ChgTypRunRIM	ChgTypRunRI I 1 = Mask 0 = Unmask	nterrup	t Mask							
PrChgTypIM	PrChgTypel Into 1 = Mask 0 = Unmask	errupt N	1ask							
DCDTmoIM	DCDTmrl Interr 1 = Mask 0 = Unmask	upt Ma	sk							
ChgTypIM	ChgTypI Interru 1 = Mask 0 = Unmask	ıpt Mas	<							

Table 28. CCIntMask Register (0x18)

ADDRESS:	0x18							
MODE:	Read/Wr	ite						
BIT	7	6	5	4	3	2	1	0
NAME	-	VSAFE0VIM	DetAbrtIM	-	CCPinStatIM	CCIStatIM	CCVcnStatIM	CCStatIM
VSAFE0VIM	VSAFE0V 1 = Mask 0 = Unma							
DetAbrtIM	DetAbrtl 1 = Mask 0 = Unma							
CCPinStatIM	CCPinSta 1 = Mask 0 = Unma							
CCIStatIM	CCIStatI 1 = Mask 0 = Unma							
CCVcnStatIM	CCVcnSt 1 = Mask 0 = Unma							
CCStatIM	CCStatl I 1 = Mask 0 = Unma							

Table 29. LED_CTRL Register (0x19)

ADDRESS:	0x19	0x19									
MODE:	Read/Write										
BIT	7	7 6 5 4 3 2 1 0									
NAME	-	-	-	-	-	-	LEDCtrl	LEDManual			
LEDCtrl	0 = LED is O	LED Manual Control 0 = LED is OFF 1 = LED is ON									
LEDManual	0 = LED is co		ation narger state ma controlled by l								

Table 30. ThermaCfg1 Register (0x1A)

ADDRESS:	0x1A							
MODE:	Read/Write							
BIT	7	6	5	4	3	2	1	0
NAME		T1T2IFchg[2:0)]		T2T3IFchg[2:0)]	JeitaC	gR[1:0]
T1T2lFchg[2:0]	Fast Charge 000 = 0.2 x I 001 = 0.3 x I 010 = 0.4 x I 011 = 0.5 x II 100 = 0.6 x I 101 = 0.7 x I 110 = 0.8 x II 111 = 1.0 x II	FChg FChg FChg FChg FChg FChg FChg	-T2 temperatu	re zone				
T2T3IFchg[2:0]	Fast Charge 000 = 0.2 x I 001 = 0.3 x I 010 = 0.4 x I 011 = 0.5 x II 100 = 0.6 x I 101 = 0.7 x I 110 = 0.8 x II 111 = 1.0 x II	FChg FChg FChg FChg FChg FChg FChg	2-T3 temperatu	re zone				
JeitaCfgR[1:0]	01 = JEITA N 10 = JEITA N	Monitoring and Monitoring and Monitoring and	TPU SW disab TPU SW Enab TPU SW Enab bled and TPU	oled if V _{CHGIN} oled	N > V _{BDET} (10m	ns Debounce)		

Table 31. ThermaCfg2 Register (0x1B)

ADDRESS:	0x1B							
MODE:	Read/Write							
BIT	7	6	5	4	3	2	1	0
NAME	-	T3T4IFchg[2:0]	-	T3T4ENset	T1T2ENset	T3T4VFset	T1T2VFset
T3T4IFchg[2:0]	Fast Charge 000 = 0.2 x II 001 = 0.3 x II 010 = 0.4 x II 011 = 0.5 x IF 100 = 0.6 x II 101 = 0.7 x II 110 = 0.8 x IF 111 = 1.0 x IF	FChg FChg =Chg FChg FChg =Chg	-T4 temperatı	ure zone				
T3T4ENset	0 = JEITA tur	er On/Off in T3 ns charger off esn't turn char	in T3-T4 zone		ACtrSet = 1)			
T1T2ENset	0 = JEITA tur	er On/Off in T1 ns charger off esn't turn char	in T1-T2 zone		ACtrSet = 1)			
T3T4VFset	JEITA voltage 1 = Enabled 0 = Disabled	e scaling enab	le in T3-T4. (0	Only valid if JEI	TACtrSet = 1)			
T1T2VFset	JEITA voltage 1 = Enabled 0 = Disabled	e scaling enab	led in T1-T2.	(Only valid if JE	EITACtrSet = 1)			

Table 32. ThermaCfg3 Register (0x1C)

ADDRESS:	0x1C	0x1C										
MODE:	Read/Write Unless Otherwise Noted											
BIT	7	7 6 5 4 3 2 1 0										
NAME	-	-	-	-	-	-	JEITACtrSet	WarmCoolSel				
JEITACtrSet	0 = JEITA sta	JEITA Control Enable 0 = JEITA status Not affect charger 1 = JEITA status affects charger settings (See register ThermaCfg2)										
WarmCoolSel	0 = 45°C Wa	EITA Zone Th rm, 10°C Cool rm, 10°C Cool		t (Read Only)								

Table 33. ChargerCtrl1 Register (0x1D)

ADDRESS:	0x1D									
MODE:	Read/Write or	Ready-Onl	y if AppWrt	Prtct = "(1) Prote	cted" (See Tab	ole 61)				
BIT	7	6	5	4	3	2	1	0		
NAME	ChgAutoStp	BatRe0	Chg[1:0]	FreshBatDis (MAX14748B)	-	BatRo	BatReg[1:0] Chg			
ChgAutoStp	State diagram. 0 = Auto-Stop	narger Auto-Stop. Controls the transition from maintain charge to maintain charge done. See <i>Battery Charger</i> tate diagram. = Auto-Stop disabled. = Auto-Stop enabled.								
BatReChg[1:0]	BAT Recharge 00 = 200mV 01 = 300mV 10 = 400mV 11 = 500mV	Threshold.	f ChgAutoS	ta = 1, charger res	starts charging i	if V _{BAT} falls belov	v V _{BATREG} by t	this amount.		
FreshBatDis (MAX14748B)	Enable/Disable 0 = Fresh Batte 1 = Fresh Batte Note, this bit sl	ery Feature l ery Feature l	Enabled Disabled	(See Fig 4) /hen ChgEn=0.						
BatReg[1:0]	Battery Regula 00 = 8.3V 01 = 8.4V 10 = 8.5V 11 = 8.6V	tion Thresho	old							
ChgEn	On/Off Control 0 = Charger dis 1 = Charger er	sabled	(does not in	npact SYS node).						

Table 34. ChargerCtrl2 Register (0x1E)

ADDRESS:	0x1E								
MODE:	Read/Write o	r Ready-On	ly if AppWrtPrto	ct = "(1) Prot	ected" (See Ta	able 61)			
BIT	7	6	5	4	3	2	1	0	
NAME	-		VPchg[2:0] IPChg[1:0] ChgD						
VPchg[2:0]	Pre-charge V 000 = 5.7V 001 = 5.8V 010 = 5.9V 111 = 6.0V 100 = 6.1V 101 = 6.2V 110 = 6.3V 111 = 6.4V	oltage Thres	hold Setting						
IPChg[1:0]	Pre-charge C 00 = 0.05 x IF 01 = 0.1 x IFC 10 = 0.2 x IFC 11 = 0.3 x IFC	FChg Chg Chg	g						
ChgDone[1:0]	Charge Done 00 = 0.05 x IF 01 = 0.1 x IFC 10 = 0.2 x IFC 11 = Reserve	FChg Chg Chg	etting						

Table 35. ChargerCtrl3 Register (0x1F)

ADDRESS:	0x1F										
MODE:	Read/Wr	ite or Ready-Only	if AppWrtPr	tct = "(1) Prote	ected" (See T	able 61)					
BIT	7	6	5	4	3	2	1	0			
NAME	-	- ChgAutoSta MtChgTmr[1:0] FChgTmr[1:0] PChgTmr[1:0]									
ChgAutoSta	0 = Char	harger Auto-Restart Control = Charger remains in maintain charge done even when VBAT is less than BAT recharge threshold. = Charger automatically restarts when VBAT drops below BAT recharge threshold.									
MtChgTmr[1:0]	00 = 0mi 01 = 15m 10 = 30m	Maintain Charge Timer Setting 10 = 0min 11 = 15min 10 = 30min 11 = 60min									
FChgTmr[1:0]	Fast- Cha 00 = 75m 01 = 150 10 = 300 11 = 600	min min									
PChgTmr[1:0]	Pre-char 00 = 30m 01 = 60m 10 = 120 11 = 240	nin min									

Table 36. ChargerCtrl4 Register (0x20)

ADDRESS:	0x20	x20									
MODE:	Read-Onl	Read-Only				Read/Write or R "(1) Protected"	pWrtPrtct =				
BIT	7 6 5			4	3	2	1	0			
NAME	W	/eakBatStat[[2:0]	-	WeakBatEn	-	-				
WeakBatStat[2:0]	000 = Idle 001 = Bat 010 = We 011 = God 100 = We	Weak Battery FSM status 000 = Idle, charger is not SDP 001 = Battery condition check 010 = Weak Battery 2-minute counter running 011 = Good Battery. 100 = Weak Battery 2-minute counter expired									
WeakBatEna	0 = Disab	Weak Battery FSM Enable 0 = Disable 1 = Enable									

Table 37. CurLimCtrl Register (0x21)

ADDRESS:	0x21										
MODE:	Read/Write										
BIT	7	6	5	4	3	2	1	0			
NAME	CurLim1Frc	CurLim1Frc FSUSMsk - CurLim1Set[4:0]									
CurLim1Frc		Forced Input Current Limit Enable. When CurLim1Frc is 1, the input current limit is by the CurLim1Set[4:0]. 0 = Not forced 1 = Forced									
FSUSMsk	0 = FSUS pin	FSUS pin function mask. If FSUSMsk is 1, FSUS pin status is ignored. 0 = FSUS pin function enabled 1 = FSUS pin function disabled									
CurLim1Set[4:0]	Forced Input (00000 = 0.10A 00001 = 0.20A 11101 = 3.00A 11110 = Reser 11111 = Reser	A A rved	/alue. The in	put current lim	it is forced to t	this value if Cu	rLim1Frc is se	t to 1.			

Table 38. CurLimStatus Register (0x22)

ADDRESS:	0x22						,			
MODE:	Read Only									
BIT	7	6	5	4	3	2	1	0		
NAME	C	CurLim2Rb[2:0] SpvChgllim[4:0]								
CurLim2Rb[2:0]	Active Char 0 = 20% 1 = 30% 2 = 40% 3 = 50% 4 = 60% 5 = 70% 6 = 80% 7 = 100%	1 = 30% 2 = 40% 3 = 50% 4 = 60% 5 = 70% 6 = 80%								
SpvChgllim[4:0]	SpvChgllim 00000 = 0.1 00001 = 0.2 11101 = 3.0 11110 = Res	10A 20A 00A served	ne actual inpi	ut current limit	currently set.					

Table 39. BBCFG1 Register (0x23)

ADDRESS:	0x23	0x23								
MODE:	Read/Write	Read/Write or Ready-Only if AppWrtPrtct = "(1) Protected" (See Table 61)								
BIT	7	6	5	4	3	2	1	0		
NAME		BoostRC	omp[3:0]		-	-	-	-		
BoostRComp[3:0]	Sets the inte 0000 = 9.5kg 0001 = 17.3kg 0010 = 25.3kg 0011 = 33.2kg 0100 = 41.4kg 0110 = 57.3kg 0111 = 65.1kg 1000 = 73.6kg 1001 = 81.4kg 1010 = 89.4kg 1011 = 97.2kg 1100 = 105.5g 1101 = 113.3g 1110 = 121.4g 1111 = 129.2g	KA KA KA KA KA KA KA KA KA KA KA KA KA K	sation resisto	for the boos	t mode					

Table 40. BBCFG2 Register (0x24)

ADDRESS:	0x24									
MODE:	Read/Write	or Ready-Onl	y if AppWrtF	Prtct = "(1) Prote	cted" (See Ta	able 61)				
BIT	7	6	5	4	3	2	1	0		
NAME	-	-	_	BBFrcZX	BBFrcZX BuckVSet[3:0]					
BBFrcZX	BBFrcZX sets the Buck in forced ZX mode. 0 = Forced PWM Mode 1 = Forced ZX Mode									
BuckVSet[3:0]	Buck Regula 0000 = 4.0V 0001 = 4.1V 0010 = 4.2V 0011 = 4.3V 0100 = 4.4V 0101 = 4.6V 0111 = 4.7V 1000 = 4.8V 1001 = 4.9V 1010 = 5.0V 1011 = 5.1V 1100 = 5.2V 1101 = 5.3V 1110 = 5.4V 1111 = 5.5V									

Table 41. BCCtrl1 Register (0x25)

ADDRESS:	0x25					,				
MODE:	Read/Write									
BIT	7	6	5	4	3	2	1	0		
NAME	DCD2s	SfOutLvl	-	ADC3PDet	SfOut	Ctrl[1:0]	ChgDetMan	ChgDetEn		
DCD2s	DCD2s sets to 0 = standard 1 = 2s									
SfOutLvI	SFOUT Volta 0 = 5V 1 = 3.3V									
ADC3PDet		3A DCP Detection Enable (adds detection step after BC1.2 completes to detect presence of 3A DCP) 0 = Not Enabled 1 = Enabled								
SfOutCtrl[1:0]	00 = Always 01 = On if a v 10 = Turns on a. ChgD b. ChgD 11: RFU Note: CHGIN SRC_CCx m According to	valid CHGIN von under followin etEn = 1, CHO etEn = 0, and N valid can be ode. A system	oltage is presing conditions. GIN is valid, a CHGIN is valid. external CHG that supports fication, CHG	ind BC1.2 FSM [lid GIN voltage or Ch s power swap mu GIN will collapse	HGIN voltage ust not use S	e generated b	y reverse buck in o supply USB trai turns off SFOUT I	nsceiver.		
ChgDetMan	ChgDetMan forces manual run of charger detection. (Bit auto-resets to 0) 0 = Not enabled 1 = Request manual run of charger detection									
ChgDetEn	Charger Dete 0 = Not enab 1 = Enabled	led	tion runs eve	ry time V _{CHGIN} :	> V _{BDET} and	d DetAbrt = 0)			

Table 42. Reserved Register (0x26)

ADDRESS:	0x26							
MODE:	Read Only							
BIT	7	6	5	4	3	2	1	0
NAME	-	-	-	-	-	-	-	-

Table 43. CCCtrl1 Register (0x27)

ADDRESS:	0x27									
MODE:	Read/Write									
BIT	7	6	5	4	3	2	1	0		
NAME	-	-	-	CCSrcSnk	CCSnkSrc	CCDbgEn	CCAudEn	CCDetEn		
CCSrcSnk	Allow State ma mode. 0 = Disable 1 = Enable	0 = Disable								
CCSnkSrc	Allow State ma mode. 0 = Disable 1 = Enabled	0 = Disable								
CCDbgEn	Enable Detection 0 = Disabled 1 = Enabled	on of Type-C	Debug Adapt	er						
CCAudEn	Enable Detection 0 = Disabled 1 = Enabled									
CCDetEn	Enable CC Pin 0 = Disabled 1 = Enabled	Detection –	Force State N	lachine to Disa	bled State.					

Table 44. CCCtrl2 Register (0x28)

ADDRESS:	0x28									
MODE:	Read/Write									
BIT	7	6	5	4	3	2	1	0		
NAME	CCForceError	SnkAttachedLock	CCSnkSrcSwp	CCSrcSnkSwp	CCVcnSwp	CCVcnEn	CCSrcRst	CCSnkRst		
CCForceError	0 = No action	o 0 after a write (This bit resets to 0 automatically when action is done)								
SnkAttachedLock	0 = Exit Attach	after a minimum c ed.SNK* state wh Attached.SNK* sta	en V _{CHGIN} < V _E							
CCSnkSrcSwp				This bit must be	written to 0 o	nce the USI	B PD contro	ller		
CCSrcSnkSwp		•		This bit must be	written to 0 o	nce the USI	B PD contro	ller		
CCVcnSwp	automatically	lachine to Swap V when action is dor e in V _{CONN} role ge in V _{CONN}		resets to 0 after	a write (Note	this bit will	reset to 0			
CCVcnEn		V _{CONN} _{ONN} off (both exter operation based o			switch)					
CCSrcRst	0 = No reset	force a reset of the State Machine – Immediate transition to Unattached.SRC* state. Bit resets to 0 after a write. = No reset = Request reset								
CCSnkRst	Force a reset of 0 = No reset 1 = Request re	of the State Machir	ne – Immediate tr	ansition to Unatt	ached.SNK* s	state. Bit res	ets to 0 afte	r a write.		

^{*} Attached.SNK, Unattached.SRC, and Unattached.SNK are defined in USB Type-C Specificaiton Release 1.1.

Table 45. CCCtrl3 Register (0x29)

ADDRESS:	0x29										
MODE:	Read/Write										
BIT	7	6	5	4	3	2	1	0			
NAME	-	-	-	-	CCTrySnk	CCPreferSnk	CCDRPF	Phase[1:0]			
CCTrySnk	that stror 0 = Disal	Enable transition from AttachWait.SRC* to Try.SNK* then to Attach.SNK_CCx* or to TryWait.SRC* for DRP that strongly prefers the SNK role. CCTrySnk has higher priority than CCPreferSnk. 0 = Disabled 1 = Enabled									
CCPreferSnk	Enable to the SNK 0 = Disal 1 = Enab	role. oled	Jnattached.SF	RC* to Try.S	NK* then to Un	attached.SNK* fo	or DRP that str	ongly prefers			
CCDRPPhase[1:0]	00 = 35% 01 = 40% 10 = 45%	Percent of time device is acting as Unattached.SRC* when CCSNKSRC = 1 00 = 35% 01 = 40% 10 = 45% 11 = 50%									

^{*} AttachWait.SRC, Try.SNK, Attached.SNK, TryWait.SRC, Unattached.SNK, and Unattached SRC are defined in USB Type-C Specificaiton Release 1.1.

Table 46. CHGINILim1 Register (0x2A)

ADDRESS:	0x2A								
MODE:	Read Only								
BIT	7	6	5	4	3	2	1	0	
NAME	- CHGINILim[6:0]								
CHGINILim[6:0]	Status of chi all 100mA. 0000000 = 1 0000001 = 1 0000010 = 1 0000010 = 1 0000011 = 1 1111111 = 40	100mA 100mA 100mA 00mA 133mA 66mA	urrent limit se	et by charger c	detection (in 33	3mA step). Note	e that the first 4	l codes are	

Table 47. CHGINILim2 Register (0x2B)

ADDRESS:	0x2B											
MODE:	Read/Writ	Read/Write										
BIT	7	6	5	4	3	2	1	0				
NAME	-	CHGINILimGate SDPMaxCur[1:0] CDPMaxCur										
CHGINILimGate	0 = No gat	CHGINILim Control options 0 = No gating of CHGINILim setting by BC1.2 FSM 1 = Gate changes in CHGINILim until BC1.2 FSM completes – ChgTypRun = 0										
SDPMaxCur[1:0]	indicating 00 = No m 01 = Limit 10 = Limit	1.5A or 3A. odification SDP to 500 SDP to 1.0	Requires of CHGIN_ mA. ChgT A. ChgTyp	CHGINIL _LIM Jyp = 01 (= 01 (SE	USB-C to USB-A c imGate = 1. SDP) and PrChgTyp DP) and PrChgTyp = DP) and PrChgTyp =	o = 000 (unkno 000 (unknowr	wn) set CHG n) set CHGIN	INILim[6:0] to 0x0F ILim[6:0] to 0x1E				
CDPMaxCur	CDP Nonstandard Type-C cable control. USB-C to USB-A cables may have incorrect CC resistor indicating 3A. Requires CHGIN_LIM_Gate = 1. 0 = No modification of CHGIN_LIM 1 = Limit CDP to 1.5A. ChgTyp = 10 (CDP) and PrChgTyp = 000 (unknown) set CHGINILim[6:0] to 0x2D											

Table 48. AICLCFG1 Register (0x2C)

ADDRESS:	0x2C	0x2C										
MODE:	Read/Write or Ready-Only if AppWrtPrtct = "(1) Protected" (See Table 61)											
BIT	7	6	5	4	3	2	1	0				
NAME	AICLEn	-	-	-	-	-	-	AlCLAbort				
AICLEn	allowed. This bit a 0 = No Action	AICL Enable. Writing 1 to AICLEn enables AICL operation. Note that if AICLAbort is 1, AICL operation is not allowed. This bit auto-resets to 0. 0 = No Action 1 = AICL enabled										
AICLAbort	0 = Device is allow	High Priority AICL Abort. 0 = Device is allowed to run AICL by writing 1 to AICLEn. 1 = Device is NOT allowed to run AICL operation. AICL operation will be aborted if it's already running.										

Table 49. AICLCFG2 Register (0x2D)

ADDRESS:	0x2D									
MODE:	Read/Write	or Ready-Only	if AppWrtPrt	ct = "(1) Prot	ected" (See T	able 61)				
BIT	7	6	5	4	3	2	1	0		
NAME	I	BYPUVLO[2:0] AICLMaxI[4:0]								
BYPUVLO[2:0]	VBUS Thesh 000 = 3.8V 001 = 3.9V 010 = 4.0V 011 = 4.1V 100 = 4.2V 101 = 4.3V 110 = 4.4V 111 = 4.5V	old below whic	h AICL stops i	ncrementing t	he current					
AICLMaxI[4:0]	AICL Stop Ct 00000 = 1000 00001 = 2000 11111 = 3.2A	mA	A step)							

Table 50. AICLCFG3 Register (0x2E)

ADDRESS:	0x2E										
MODE:	Read/Write or Ready-Only if AppWrtPrtct = "(1) Protected" (See Table 61)										
BIT	7	6	5	4	3	2	1	0			
NAME	-	BYPDeb AICLTBlk[1:0] AICLTStep[1:0]									
BYPDeb	AICL BYPU 0 = 500μs 1 = 200μs	·									
AICLTBIk[1:0]	TBLANK Tir 00 = 500ms 01 = 1s 10 = 1.5s 11 = 5s	•									
AICLTStep[1:0]	TSTEP Time 00 = 100ms 01 = 200ms 10 = 300ms 11 = 500ms										

Table 51. DPDNSw Register (0x2F)

ADDRESS:	0x2F	0x2F										
MODE:	Read/Write	Read/Write										
BIT	7	7 6 5 4 3 2 1 0										
NAME	-	AnSwCntl[1:0]										
AnSwCntl[1:0]	00 = Auto. 3 01 = Auto ii 10 = Switch		during adapte and Buck mod	er detection. Sv de is detected.	vitch closes if S	SDP or CDP is	detected.					

Table 52. Others Register (0x30)

ADDRESS:	0x30	0x30							
MODE:	Read/Write	Read/Write							
BIT	7	6	5	4	3	2	1	0	
NAME	-	-	-	-	-	-	-	USBCRSet	
USBCRSet	this operation	n opens the in Table 59 and T n	•	turns off the b	oost converter	ciated with USE temporarily.) R s to 0.		,	

Table 53. Reserved Register (0x31)

ADDRESS:	0x31							
MODE:	Read Only							
BIT	7	6	5	4	3	2	1	0
NAME	-	-	-	-	-	-	-	-

Table 54. Reserved Register (0x32)

ADDRESS:	0x32							
MODE:	Read Only							
BIT	7	6	5	4	3	2	1	0
NAME	-	-	-	-	-	-	-	-

Table 55. LowPow Register (0x33)

ADDRESS:	0x33	0x33						
MODE:	Read/Write	Read/Write						
BIT	7	6	5	4	3	2	1	0
NAME	LowPowEn	-	-	-	-	-	-	LowPowAbort
LowPowEn	Power Mode 0 = No Action	Low Power Mode Enable. Set LowPowEn to 1 to enter Low Power mode. Note that if LowPowAbort is 1, Low Power Mode is not allowed. This bit auto-resets to 0. 0 = No Action 1 = Enter Low Power mode						
LowPowAbort		allowed to en	ter Low Powe	r mode by writir Power Mode. Lo			ed if dev	ice has already

Table 56. Reserved Register (0x34)

ADDRESS:	0x34							
MODE:	Read Only	1						
BIT	7	6	5	4	3	2	1	0
NAME	-	-	-	-	-	-	-	-

Table 57. FLTSel Register (0x35)

ADDRESS:	0x35	0x35							
MODE:	Read/Writ	Read/Write							
BIT	7	7 6 5 4 3 2 1 0							
NAME	FLTS	elect[1:0]	-	-	-	-	-	-	
FLTSelect[10]	00 = No ef 01 = Low o (ChgStat[3 1x = Falling	orger-Faulting an fect and interna on FLTIN pin (60 t:0] = 1000). g edge on FLTII or more details.	lly ignored)μs debounce) _) places the ch	arger in Batter	_	-		

Appliications Information

Component Selection

The correct selection of external components ensures high efficiency, low output ripple, and fast transient response.

Inductor Selection

The MAX14748 is designed to use a 1.5 μ H or 2.2 μ H inductor. See <u>Table 58</u> for suggested inductors and manufacturers.

BAT Capacitor Selection

BAT capacitor is required to keep the BAT voltage ripple small and to ensure regulation loop stability. The BAT capacitor must have low impedance at the switching frequency. Ceramic capacitors with X5R or X7R dielectric are highly recommended due to their small size, low ESR, and small temperature coefficients.

BAT requires careful bypassing. In the PCB layout, place BAT capacitor as close as possible to BAT to minimize parasitic inductance. If making connections to BAT capacitor through vias, ensure that the vias are rated for the expected input current to avoid excess inductance and resistance between the capacitor and BAT.

The recommended nominal BAT capacitance is $22\mu F$, however, after initial tolerance, bias voltage, aging, and temperature derating, the effective capacitance must be greater than $10\mu F$. To ensure regulation loop stability, the effective BAT capacitance should be chosen within the range of $10\mu F$ to $30\mu F$.

SYS Capacitor Selection

SYS capacitor acts as the output capacitor for the boost converter when charging, and the input capacitor for the reverse buck converter when the device is acting as power source in DRP mode. SYS capacitor is required to keep the SYS voltage ripple small and to ensure regulation loop stability. It must have low impedance at the switching frequency. Ceramic capacitors with X5R or X7R dielectric are highly recommended due to their small size, low ESR, and small temperature coefficients.

Place SYS capacitor as close as possible to SYS to minimize parasitic inductance. If making connections to SYS capacitor through vias, ensure that the vias are rated for the expected input current to avoid excess inductance and resistance between the capacitor and SYS.

The recommended nominal SYS capacitance is $40\mu\text{F}$, however, after initial tolerance, bias voltage, aging, and temperature derating, the effective capacitance must be greater than $15\mu\text{F}$.

BYP Capacitor Selection

BYP capacitor acts as the input capacitor for the boost converter, and the output capacitor for the reverse buck converter. BYP capacitor reduces the current peaks drawn from the input power source when charging while reducing the output voltage ripple of the reverse buck converter when it is acting as power source in DRP mode. The impedance of the input capacitor at the switching frequency should be very low. Ceramic capacitors with X5R or X7R dielectric are highly recommended due to their small size, low ESR, and small temperature coefficients.

Table 58. Suggested Inductors

APPLICATION	INDUCTANCE (µH)	R _{DC} (MΩ)	SATURATION CURRENT (A)	CURRENT RATING (A)	SUGGESTED PARTS
3A Type-C	2.2µH	26	4.2	3.7	Taiyo Yuden NRS6028T2R2NMGJ
Adapters	2.2µH	80	3.5	2.8	BOURNS SRP4012TA-2R2M

Table 59. Reset Types

RESET TYPE	RESET CONDITION
RST	1. V _{CCINT} Power-On Reset
RST1	1. V _{CCINT} Power-On Reset or 2. FLTIN falling edge (only if FLTSelect[1] = 1)
RST2	V _{CCINT} Power-On Reset or FLTIN falling edge (only if FLTSelect[1] = 1) or VBUSDet rising edge
RST3	V _{CCINT} Power-On Reset or FLTIN falling edge (only if FLTSelect[1] = 1) or USB-C reset through USBCRSet (0x30[0])

MAX14748

BYP requires careful bypassing. In the PCB layout, place BYP capacitor as close as possible to the BYP to minimize parasitic inductance. If making connections to BYP capacitor through vias, ensure that the vias are rated for the expected input current to avoid excess inductance and resistance between the capacitor and BYP.

The recommended nominal BYP capacitance is $22\mu F$, however, after initial tolerance, bias voltage, aging, and temperature derating, the effective capacitance must be greater than $10\mu F$.

CHGIN Capacitor Selection

CHGIN capacitor decouples a charge source and its parasitic impedance. Typically, the charger source at CHGIN is a USB connector's VBUS. The recommended nominal CHGIN capacitance is $1\mu F$. Larger capacitance at CHGIN improves the decoupling; however, take care not to exceed the maximum capacitance allowed by the USB specification.

The impedance of the CHGIN at the DC-DC switching frequency should be very low. Ceramic capacitors with X5R or X7R dielectric are highly recommended due to their small size, low ESR, and small temperature coefficients.

To fully utilize the +30V input capability of the, choose a capacitor with a 35V or greater rating; many applications don't need to utilize the full input capability of the device and find that a 16V or 10V rated input capacitor is sufficient.

BST Capacitor Selection

Choose the nominal BST capacitance to be $0.1\mu F$. BST capacitor is part of a charge pump that creates the high-side gate drive for the DC-DC. It is recommended that the BST capacitor has at least 10V rating.

PCB Layout and Routing

High switching frequencies and large peak currents make PCB layout a very important part of design. Good design minimizes excessive EMI on the feedback paths and voltage gradients in the ground plane, both of which can result in instability or regulation errors. Connect the inductor, input capacitors, and output capacitors as close together as possible, and keep their traces short, direct, and wide. Keep noisy traces, such as the LX node, as short as possible.

Table 60. Register Reset Types and Default Values

REGISTER ADDRESS	REGISTER NAME	RESET TYPE	MAX14748
0x00	ChipID	RST1	0x3E
0x01	ChipRev	RST1	0x44
0x02	DevStatus1	RST1	STATUS*
0x03	AICLStatus	RST1	STATUS
0x04	DevStatus2	RST1	STATUS
0x05	ChgStatus	RST1	STATUS
0x06	JEITAStatus	RST1	STATUS
0x07	BCStatus	RST3	STATUS
80x0	Reserved	-	0x00
0x09	CCStatus1	RST3	STATUS
0x0A	CCStatus2	RST3	STATUS
0x0B	DevInt1	RST1	INT*
0x0C	AICLInt	RST1	INT
0x0D	DevInt2	RST1	INT
0x0E	ChgInt	RST1	INT
0x0F	JEITAInt	RST1	INT
0x10	BCInt	RST3	INT
0x11	CCInt	RST3	INT
0x12	DevInt1Mask	RST1	0xFF
0x13	AICLIntMask	RST1	0x40
0x14	DevInt2Mask	RST1	0x7F
0x15	ChgIntMask	RST1	0xF1
0x16	JEITAIntMask	RST1	0x19
0x17	BCIntMask	RST3	0xFF
0x18	CCIntMask	RST3	0x7F
0x19	LED_CTRL	RST1	0x00
0x1A	ThermaCfg1	RST2	0x7D
0x1B	ThermaCfg2	RST2	0xEF
0x1C	ThermaCfg3	RST2	0x02

REGISTER ADDRESS	REGISTER NAME	RESET TYPE	MAX14748
0x1D	ChargerCtrl1	RST2	0x80
0x1E	ChargerCtrl2	RST2	0x10
0x1F	ChargerCtrl3	RST2	0x49
0x20	ChargerCtrl4**	RST2	0x06
0x21	CurLimCtrl	RST2	0x00
0x22	CurLimStatus	RST1	STATUS
0x23	BBCFG1	RST1	0x20
0x24	BBCFG2	RST1	0x8A
0x25	BCCtrl1	RST3	0x05
0x26	Reserved	-	0x00
0x27	CCCtrl1	RST3	0x19
0x27 (MAX14748B)	CCCtrl1	RST3	0x11
0x28	CCCtrl2	RST3	0x04
0x29	CCCtrl3	RST3	0x08
0x2A	CHGINILim1	RST3	STATUS
0x2B	CHGINILim2	RST3	0x0B
0x2C	AICLCFG1	RST1	0x01
0x2D	AICLCFG2	RST1	0x44
0x2E	AICLCFG3	RST1	0x05
0x2F	DPDNSw	RST2	0x01
0x30	Others	RST1	0x00
0x31	Reserved	-	0x00
0x32	Reserved	-	0x00
0x33	LowPow	RST1	0x01
0x34	Reserved	-	0x01
0x35	FLTSel	RST	0x80

^{*}INT and STATUS: status and interrupt register values vary based on device operating condition.

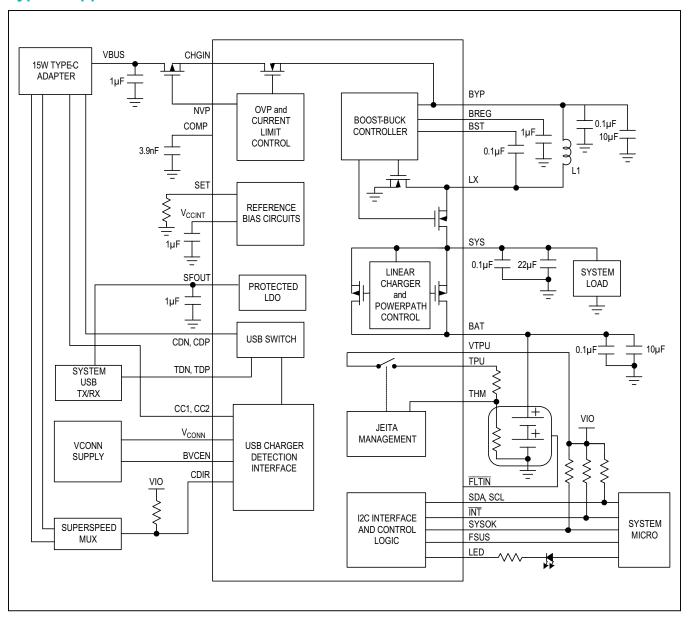
^{**} ChargerCtrl4 register value depends on the status of WeakBatStat[2:0] bits.

Table 61. Register Bit Default Values

REGISTER BITS	VALUES		
CDPMaxCur	1500mA		
SDPMaxCur[1:0]	500mA		
CHGINILimGate	Gating		
CCAudEn	Disabled		
CCDbgEn	Disabled		
CCSnkSrc	Disabled		
CCSrcSnk	Enabled		
JeitaCfgR[1:0]	"01"		
CCDRPPhase[1]	35% or 40%		
CCTrySnk	Enabled		
SfOutCtrl[1:0]	"01"		
ADC3PDet	Disabled		
DCD2s	Standard		
WarmCoolSel	45°C/10°C		
T1T2IFchg[2:0]	0.5 x IFChg		
T3T4IFchg[2:0]	1.0 x IFChg		
BatReg[1:0]	8.3V		
ChgEn	Disabled		
JETIACtrSet	(1) Control		
IPChg[1:0]	0.05 x IFChg		
ChgDone[1:0]	0.05 x IFChg		
ChgAutoStp	Enabled		
BatReChg[1:0]	100mV		

REGISTER BITS	VALUES		
FreshBatDis	Done		
ChgAutoSta	Enabled		
MtChTmr[1:0]	0min		
FChgTmr[1:0]	300min		
PChgTmr[1:0]	60min		
ChipRevH[3:0]	3		
AppWrtPrtct	(0) Writable		
VPchg[2:0]	5.8V		
T3T4ENset	Enabled		
T1T2ENset	Enabled		
T3T4VFset	Enabled		
T1T2VFset	Enabled		
T2T3lFchg[2:0]	1.0 x IFChg		
BoostRComp[3:0]	2		
FLTSelect[1:0]	(10) Reset		
BuckVSet[3:0]	5.0V		
AnSwCntl[1:0]	(01) Auto		
AICLTStep[1:0]	200ms		
WeakBatEna	Enabled		
BYPUVLO{2:0]	4.0V		
AICLMax[4:0]	500mA		
BYPDeb	500µs		
AICLTBIk[1:0]	1000ms		

Typical Application Circuit



Note: All capacitance values listed in this document refer to effective capacitance. Be sure to specify capacitors that will meet these requirements under typical system operating conditions taking into consideration the effects of voltage and temperature.

Ordering Information

PART	TEMP RANGE	PIN-PACKAGE
MAX14748EWW+	-40°C to +85°C	54 WLP
MAX14748EWW+T	-40°C to +85°C	54 WLP
MAX14748BEWW+*	-40°C to +85°C	54 WLP
MAX14748BEWW+T*	-40°C to +85°C	54 WLP

⁺Denotes a lead(Pb)-free package/RoHS-compliant package. See <u>Table 61</u> for the device differences.

Chip Information

PROCESS: BICMOS

Package Information

For the latest package outline information and land patterns (footprints), go to www.maximintegrated.com/packages. Note that a "+", "#", or "-" in the package code indicates RoHS status only. Package drawings may show a different suffix character, but the drawing pertains to the package regardless of RoHS status.

PACKAGE	PACKAGE	OUTLINE	LAND
TYPE	CODE	NO.	PATTERN NO.
54 WLP	W542C3+1	21-100122	Refer to Application Note 1891

T = Tape and reel.

^{*}Denotes a future product.

Revision History

REVISION NUMBER	REVISION DATE	DESCRIPTION	PAGES CHANGED
0	6/17	Initial release	_
1	12/17	I AOOPO MAX 14748C. 38 HITTE DIOOUCI	1, 6, 27, 29, 35, 36, 52, 58, 59, 67, 68, 70
2	3/18	Updated <i>Bump Configuration</i> , Figure 4, <i>Register Map</i> , Table 33, Table 60, and <i>Ordering Information</i> table	15, 27, 35, 52,
3	4/18	Updated Electrical Characteristics table, Register Map, Tables 8, 17, 24, 33	3, 35, 38, 43, 47, 52
3.1	5/18	Corrected Bump Configuration typo	15

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